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Structure variations within *RSi*₂ and *R*₂*TSi*₃ silicides. Part I. Structure overview

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Here, structural parameters of various structure reports on RSi_2 and R_2TSi_3 compounds [where R is an alkaline earth metal, a rare earth metal (*i.e.* an element of the Sc group or a lathanide), or an actinide and T is a transition metal] are summarized. The parameters comprising composition, lattice parameters a and c, ratio c/a, formula unit per unit cell and structure type are tabulated. The relationships between the underlying structure types are presented within a group–subgroup scheme (Bärnighausen diagram). Additionally, unexpectedly missing compounds within the R_2TSi_3 compounds were examined with density functional theory and compounds that are promising candidates for synthesis are listed. Furthermore, a correlation was detected between the orthorhombic AlB₂-like lattices of, for example, Ca₂AgSi₃ and the divalence of R and the monovalence of T. Finally, a potential tetragonal structure with ordered Si/T sites is proposed.

1. Introduction

The rare earth disilicides RSi₂ have been the subject of numerous studies in the past few decades mainly due to their exciting magnetic properties, such as magnetic ordering phenomena (Wang et al., 2019; Pan et al., 2013; Kotsanidis et al., 1990; Li et al., 1998a, 2002a, 2013; Bazela et al., 2003; Inosov et al., 2009), especially ferromagnetic ordering (Majumdar et al., 1998, 1999b; Li et al., 1999, 2002a,b, 2003, 2013; Frontzek et al., 2004), their spin-glass-like behavior (Li et al., 1998a, 1999, 2002b, 2003; Kimura et al., 1999; Szytuła et al., 1999, 2000; Paulose et al., 2003; Lu et al., 2013) and Ruderman-Kittel-Kasuya-Yosida (RKKY) interactions (Li et al., 2002b; Inosov et al., 2009; Tang et al., 2010a,b; Lu et al., 2013), which have been studied since the early 1980s. In the middle of the 20th century, ternary compounds of composition U_2TSi_3 (with a transition metal T substituting one in four Si atoms) were a central research subject due to the emerging use of Ucontaining compounds in the military and the energy sector. Some of the formed structures are considered as prototypes for further R_2TSi_3 compounds.

As it has been widely discussed in the literature (Hoffmann & Pöttgen, 2001; Pan *et al.*, 2013; Peter & Kanatzidis, 2012), the RSi_2 and R_2TSi_3 compounds crystallize with the hexagonal AlB₂ and the tetragonal ThSi₂ type and derivative structure types (Hoffmann & Pöttgen, 2001). Some of the disilicides are polymorphic (Perri *et al.*, 1959b; Brown & Norreys, 1961; Mayer *et al.*, 1967), meaning that they crystallize in two or more different phases (International Union for Crystal-

lography, 2017). This reflects in the now obsolete structuretype names α -USi₂ and α -ThSi₂ for tetragonal ThSi₂ as well as β -USi₂ and β -ThSi₂ for hexagonal AlB₂ (Evers *et al.*, 1980; Yashima *et al.*, 1982*a,b,c*; Yashima & Satoh, 1982; Lejay *et al.*, 1983; Evers *et al.*, 1983; Weigel *et al.*, 1984; Sato *et al.*, 1984; Zhong *et al.*, 1985; Chevalier *et al.*, 1986; Dhar *et al.*, 1987).

The relationship between the large variety of the derivatives from AlB₂ and ThSi₂ aristotypes can be nicely explained within the group–subgroup scheme, also known as Bärnighausen formalism (Bärnighausen, 1980). The AlB₂ structure is one of the simplest inorganic structure types. It has hexagonal space group *P6/mmm* (No. 191) and its unit cell incorporates only the two Wyckoff sites 1*a* and 2*d* (Hofmann & Jäniche, 1935) occupied by one *R* atom on the Al site and two Si atoms on the B site, forming a two-dimensional Si network, similar to graphite. The unit cell of the ThSi₂ structure also has only two occupied Wyckoff positions (4*a* and 8*e*), but the Si sublattice forms a more complex 3D network (Brauer & Mittius, 1942).

Nowadays, 46 structure types derived from AlB₂ (Hoffmann & Pöttgen, 2001) and four from ThSi₂ are known. They include binary and ternary intermetallic compounds with compositions RX_2 , RT_2 , RTX or R_2TX_3 , where X is an element of the third or fourth group.

In this work, we systematize the occurrence of RSi_2 and R_2TSi_3 compounds, where R = alkaline earth metal, lanthanide, actinide or member of the Sc group and T is a transition metal. We present 12 different structure types of these compounds derived from the AlB₂ type. Six of these structure types have not been considered by Hoffmann & Pöttgen (2001). Additionally, we present three further structure types based on the tetragonal ThSi₂ type. One of these types is purely hypothetical and considers the possibility of ordered Si/ T positions in ThSi₂-like structures. Furthermore, we order all structure reports for RSi_2 and R_2TSi_3 compounds according to their R and T elements within an R-T grid. After analyzing all element combinations, we choose nine promising compounds not found in the literature and perform DFT calculations to evaluate the probability of a successful synthesis. We discuss peculiarities of the distribution of structure types among the RSi_2 and R_2TSi_3 compounds, based on a mapping of symmetries on the R-T grid with corresponding symbols.

2. Methods

To gain a comprehensive overview of RSi_2 and R_2TSi_3 compounds, we performed an extensive literature search by scanning the ICSD, SciFinder and Reaxys databases for all possible element combinations for T within the Cr to Zn groups and R within the Sc group, the alkaline earth metal, the lanthanides and the actinides. Only experiments at ambient conditions were considered. Additionally, we did not consider data sets if they were too incomplete, *i.e.* missing lattice parameters or an insufficient description of the symmetry. Additionally, we did not take incommensurately modulated structures into account, because these modulations mainly arise for nonstoichiometric disilicides within this family of compounds and because the descriptions do not conform with those of conventional symmetry. Please refer to Leisegang (2010), Kubata *et al.* (2005) and Dshemuchadse (2008) for further information. However, commensurable modulations are interpreted as superstructures.

Table 1 contains the tabulated data of the composition of the compounds as well as their structure parameters, *i.e.* lattice parameters a and c, ratios c/a, formula units per unit cell, and structure type. These data were used without further refinement. The compounds, discussed within this article, are more than solid solutions as most of them exhibit ordered structures and, therefore, have distinct structure types compared to similar stoichiometries. Within this article, only the formula units and the deviation of the compounds within the range of R and T elements is of interest. Part II (Nentwich *et al.*, 2020) will discuss and compare other parameters.

We used calculations based on density functional theory (DFT) to predict the stability of not yet reported RSi_2 and R_2TSi_3 compounds. The formation energy ΔE^{tot} is the difference of the total energy E^{tot} of the compound and E^{tot} of its elements, normalized to six atoms (R_2 Si₄ or R_2T Si₃). Appendix B presents the space groups of the unary R crystals. The more negative the formation energy, the more thermodynamically favorable is the formation of that compound. We considered a formation energy of up to -25 meV per atom as potentially stable at room temperature. However, this assumption does not take into account potential energy barriers which might kinetically hinder the formation of the ground state. The projector-augmented wave (PAW) method (Kresse & Joubert, 1999) in spin-polarized Perdew-Burke-Ernzerhof parametrization (Perdew et al., 1996) was employed as implemented in the VASP code (Kresse & Furthmüller, 1996). Total energies have been converged better than 10^{-7} eV with a maximum kinetic energy of 320 eV for the planewave basis set and Γ -centered k-point meshes with spacings less than 0.02 \times 2π Å⁻¹. All structures have been fully relaxed, with respect to atomic positions as well as cell geometry within the space group, to forces less than $10^{-3} \text{ V} \text{ Å}^{-1}$. A Hubbard U correlation correction was not used because the Si framework with sand p-orbitals governs the stability of the structure and because it would complicate the comparability of the formation energies within the R_2TSi_3 series.

3. Results and discussion

In this article, we treat the R_2TSi_3 compounds as a distinct phase with a fixed composition and not as a solid solution. As ternary phase diagrams are scarce for these compounds, we checked all available data, in particular the thermodynamic assessment of Bodak & Gladyshevskii (1985), for compositional degrees of freedom in the corresponding phase diagram region and possibly prevailing solid solutions. Nevertheless, the vast majority of compounds were reported to form superstructures which, in general, allow only slight variations in stoichiometry. We discuss those structures as distinct phases due to the changes in symmetry at these particular compositions in the phase diagrams. Many ternary phase diagrams are often determined at elevated temperatures, which is beyond

Table 1

Alphabetically sorted list of RSi_2 and R_2TSi_3 compounds and their crystal data.

R is an element of the alkaline earth metals, the scandium group, or the lanthanide or actinide series. T is a transition metal, Al or Si; thus a disilicide. The supercell can be identified by the formula units per unit cell. Lines written in blue indicate data sets not used for Fig. 9.

| | | | | | | Formula | Structure | Thermal | | ICSD |
|------|----------|--|-------------------|--|---|--|--|---|--|---|
| R T | | a (Å) | b (Å) | c (Å) | c/a | units | type | treatment | Reference | number |
| A | : | 4.0100 | | 12 6990 | 2 4059 | 4 | TLC: | | Weigel at al (1077) | |
| Am S | 1 | 4.0190 | | 12,7220 | 3.4058 | 4 | | - | Weigel et al. (1977) | 12016 |
| | 1.0 | 4.0130 | 14 0270 | 10,6200 | 3.4204 | 4 16 | $P_0 \downarrow S$ | - 550°C 1.5 days | $\begin{array}{c} \text{Weight } el \ al. \ (1984) \\ \text{Cardona Gil at al.} \ (1000) \\ \end{array}$ | 45810 |
| | Ag Ag | 8 3150 | 14.9270 8.6460 | 14 3010 | 1 7307 | 8 | $Da_4Ll_2Sl_6$ | 550° C, 1.5 days | Cardoso Gil <i>et al.</i> (1999) | 410520 |
| | ig Ji | 3 0880 | 8.0400 | 14.3910 | 1.7507 | 1 | AIR- | | Bodak & Gladyshevskij (1968) | 20300 |
| S | i | 4 2830 | | 13 5200 | 3 1 5 6 7 | 1 | ThSia | _ | Evers <i>et al.</i> $(1977a)$ | 1453 |
| 0. | 1 | 4 2830 | | 13.5200 | 3 1 5 6 7 | 4 | ThSia | _ | Evers et al. $(1977h)$ | 1455 |
| | | 4.2832 | | 13,5420 | 3.1617 | 4 | ThSia | _ | McWhan <i>et al.</i> $(1970b)$ | 87392 |
| | | 4.2830 | | 13.5300 | 3.1590 | 4 | ThSia | _ | Nakano & Yamanaka (1994) | 0,0,2 |
| Ce A | ۸u | 4.2220 | | 14.3750 | 3.4048 | 4 | t | 750°C, 14 days | Gordon et al. (1997) | |
| | | 8.2840 | | 8.7010 | 1.0503 | 8 | h | 750°C, 14 days | Gordon et al. (1997) | |
| | | 8.3060 | | 8.6870 | 1.0459 | 8 | Er ₂ RhSi ₃ (190/194) | Floating zone | Majumdar et al. (2000) | |
| С | Со | 4.0440 | | 4.1940 | 1.0371 | 1 | AlB ₂ | - | Bodak & Gladyshevskii (1985) | 52846 |
| | | 8.1040 | | 4.1970 | 0.5179 | 4 | Ce2CoSi3/U2RuSi3 | 750°C, 14 days | Gordon et al. (1997) | 83895 |
| | | 8.1100 | | 4.2200 | 0.5203 | 4 | Ce ₂ CoSi ₃ /U ₂ RuSi ₃ | 750°C, 7 days | Majumdar et al. (1999a) | |
| | | 8.1130 | | 4.2190 | 0.5200 | 4 | Ce2CoSi3/U2RuSi3 | Floating zone | Majumdar et al. (2000) | |
| | | 8.0890 | | 8.4020 | 1.0387 | 8 | Er ₂ RhSi ₃ (190/194) | 800°C, 5 days | Patil et al. (2008) | |
| C | Cu | 4.0600 | | 4.2800 | 1.0542 | 1 | AlB ₂ | - | Bodak & Gladyshevskii (1985) | |
| | | 4.0770 | | 4.3140 | 1.0581 | 1 | AlB ₂ | - | Gladyshevskii & Bodak (1965) | 20303 |
| | | 4.0590 | | 4.2940 | 1.0579 | 1 | AlB ₂ | - | Hwang <i>et al.</i> (1996) | |
| | | 4.0580 | | 4.2960 | 1.0586 | 1 | AlB_2 | 850°C, 7 days | Lu et al. (2013) | |
| | | 8.0920 | | 4.2060 | 0.5198 | 4 | Ce_2CoSi_3/U_2RuSi_3 | 850°C, 7 days | Lu et al. (2013) | |
| | | 4.1360 | | 4.2370 | 1.0244 | 1 | AlB ₂ | - | Raman (1967) | |
| | | 4.0650 | | 4.3020 | 1.0583 | 1 | AlB ₂ | - | Raman (1967) | |
| | | 4.0640 | | 4.3040 | 1.0591 | 1 | AlB ₂ | 800°C, 7 days | Yubuta <i>et al.</i> (2009) | |
| - | | 8.1280 | | 8.6080 | 1.0591 | 8 | Er_2RhSi_3 (190/194) | 800°C, 7 days | Yubuta <i>et al.</i> (2009) | |
| F | e | 4.0680 | | 4.1400 | 1.0177 | 1 | AIB ₂ | - | Gladyshevskii & Bodak (1965) | 20304 |
| т | | 4.0620 | | 4.2120 | 1.0369 | 1 | h | 750° C, 14 days | Gordon <i>et al.</i> (1997) | |
| II | r T | 8.2120 | | 4.2374 | 0.5160 | 4 | Ce_2CoSi_3/U_2RuSi_3 | - | Szlawska & Kaczorowski (2011) | (01(50 |
| IN | N1 | 4.0390 | | 4.2870 | 1.0614 | 1 | AIB ₂ | - | Bodak & Gladysnevskii (1985) Dhor et el (1994) | 621052 |
| | | 4.0480 | | 4.2910 | 1.0600 | 1 | | - | Gladushevskij & Bodak (1965) | 038279 |
| | | 4.0430 | | 4.3020 | 1.0041 | 1 | h | - 750°C 14 days | Gordon <i>et al.</i> (1907) | 20302 |
| | | 4.0400 | | 4.2001 | 1.0393 | 1 | | 750 C, 14 days | $\mathbf{R}_{\text{aman}} (1967)$ | |
| | | 4 0710 | | 4 2020 | 1.0322 | 1 | AlBa | _ | Raman (1967) | |
| | | 4 0485 | | 4 2887 | 1.0522 | 1 | AlBa | 800°C 7 days | Rojas <i>et al.</i> 2010) | |
| | | 4.0450 | | 4.2830 | 1.0588 | 1 | AlBa | - | Szlawska & Kaczorowski (2012) | 187100 |
| Р | d | 8.2631 | | 17.1320 | 2.0733 | 16 | h | 750°C, 14 days | Gordon <i>et al.</i> (1997) | 10/100 |
| | | 8.2330 | | 8.5650 | 1.0403 | 8 | Er ₂ RhSi ₃ (190/194) | 750°C, 7 days | Mallik & Sampathkumaran (1996) | |
| | | 4.1215 | | 4.2723 | 1.0366 | 1 | AlB ₂ | 750°C, 5 days | Szytuła et al. (1999) | |
| Р | 'nt | 8.2500 | | 4.3320 | 0.5251 | 4 | Ce2CoSi3/U2RuSi3 | 750°C, 14 days | Majumdar et al. (2001) | |
| R | Rh | 8.2100 | | 8.4100 | 1.0244 | 8 | Er ₂ RhSi ₃ | 800°C 4 days | | |
| | | 8.2310 | | | | | | 000 C, 1 aayo | Chevalier <i>et al.</i> (1984) | 621958 |
| | | | | 8.4391 | 1.0253 | 8 | Er ₂ RhSi ₃ | - | Chevalier <i>et al.</i> (1984) Kase <i>et al.</i> (2009) | 621958 |
| | | 8.3270 | | 8.4391 8.5160 | 1.0253 1.0227 | 8 8 | Er_2RhSi_3 Er_2RhSi_3 (<i>P</i> $\overline{6}2c$) | – 730°C, 4 days | Chevalier <i>et al.</i> (1984) Kase <i>et al.</i> (2009) Leciejewicz <i>et al.</i> (1995) | 621958 |
| | | 8.3270 8.2370 | | 8.4391 8.5160 8.4450 | 1.0253 1.0227 1.0253 | 8 8 8 | Er_2RhSi_3 Er_2RhSi_3 (<i>P</i> 62 <i>c</i>) Er_2RhSi_3 (190/194) | - 730°C, 4 days 800°C, 5 days | Chevalier <i>et al.</i> (1984) Kase <i>et al.</i> (2009) Leciejewicz <i>et al.</i> (1995) Patil <i>et al.</i> (2008) | 621958 |
| | | 8.3270 8.2370 8.2300 | | 8.4391 8.5160 8.4450 8.4400 | 1.0253 1.0227 1.0253 1.0255 | 8 8 8 8 | $E_{r_2}RhSi_3$ $E_{r_2}RhSi_3$ (<i>P</i> 62 <i>c</i>) $E_{r_2}RhSi_3$ (190/194) $E_{r_2}RhSi_3$ (190/194) | - 730°C, 4 days 800°C, 5 days 800°C, 5 days | Chevalier <i>et al.</i> (1984) Kase <i>et al.</i> (2009) Leciejewicz <i>et al.</i> (1995) Patil <i>et al.</i> (2008) Sengupta <i>et al.</i> (2003) | 621958 |
| | | 8.3270 8.2370 8.2300 8.2240 | | 8.4391 8.5160 8.4450 8.4400 4.2261 | 1.0253 1.0227 1.0253 1.0255 0.5139 | 8 8 8 8 4 | Er ₂ RhSi ₃ Er ₂ RhSi ₃ (<i>P</i> 62 <i>c</i>) Er ₂ RhSi ₃ (190/194) Er ₂ RhSi ₃ (190/194) Ce ₂ CoSi ₃ /U ₂ RuSi ₃ | - 730°C, 4 days 800°C, 5 days 800°C, 5 days - | Chevalier <i>et al.</i> (1984) Kase <i>et al.</i> (2009) Leciejewicz <i>et al.</i> (1995) Patil <i>et al.</i> (2008) Sengupta <i>et al.</i> (2003) Szlawska <i>et al.</i> (2009) | 621958 164827 |
| | | 8.3270 8.2370 8.2300 8.2240 8.2620 | | 8.4391 8.5160 8.4450 8.4400 4.2261 8.4390 | 1.0253 1.0227 1.0253 1.0255 0.5139 1.0214 | 8 8 8 4 8 | $E_{r_2}RhSi_3$ Er_2RhSi_3 ($P\overline{6}2c$) Er_2RhSi_3 (190/194) Er_2RhSi_3 (190/194) Ce_2CoSi_3/U_2RuSi_3 Er_2RhSi_3 ($P\overline{6}2c$) | - 730°C, 4 days 800°C, 5 days 800°C, 5 days - 800°C, 54 days | Chevalier <i>et al.</i> (1984) Kase <i>et al.</i> (2009) Leciejewicz <i>et al.</i> (1995) Patil <i>et al.</i> (2008) Sengupta <i>et al.</i> (2003) Szlawska <i>et al.</i> (2009) Szytuła <i>et al.</i> (1993) | 621958 164827 106425 |
| Si | i | 8.3270 8.2370 8.2300 8.2240 8.2620 4.1900 | | 8.4391 8.5160 8.4450 8.4400 4.2261 8.4390 13.9300 | 1.0253 1.0227 1.0253 1.0255 0.5139 1.0214 3.3246 | 8 8 8 4 8 4 | $Er_{2}RhSi_{3}$ $Er_{2}RhSi_{3}$ ($P\overline{6}2c$) $Er_{2}RhSi_{3}$ (190/194) $Er_{2}RhSi_{3}$ (190/194) $Ce_{2}CoSi_{3}/U_{2}RuSi_{3}$ $Er_{2}RhSi_{3}$ ($P\overline{6}2c$) ThSi ₂ | - 730°C, 4 days 800°C, 5 days 800°C, 5 days - 800°C, 54 days | Chevalier <i>et al.</i> (1984) Kase <i>et al.</i> (2009) Leciejewicz <i>et al.</i> (1995) Patil <i>et al.</i> (2008) Sengupta <i>et al.</i> (2003) Szlawska <i>et al.</i> (2009) Szytuła <i>et al.</i> (1993) Benesovsky <i>et al.</i> (1966) | 621958 164827 106425 |
| Si | i | 8.3270 8.2370 8.2300 8.2240 8.2620 4.1900 4.2700 | | 8.4391 8.5160 8.4450 8.4400 4.2261 8.4390 13.9300 13.8800 | 1.0253 1.0227 1.0253 1.0255 0.5139 1.0214 3.3246 3.2506 | 8 8 8 4 8 4 4 4 | Er_2RhSi_3 Er_2RhSi_3 ($P\overline{6}2c$) Er_2RhSi_3 (190/194) Er_2RhSi_3 (190/194) Ce_2CoSi_3/U_2RuSi_3 Er_2RhSi_3 ($P\overline{6}2c$) $ThSi_2$ $ThSi_2$ | - 730°C, 4 days 800°C, 5 days 800°C, 5 days - 800°C, 54 days - | Chevalier <i>et al.</i> (1984) Kase <i>et al.</i> (2009) Leciejewicz <i>et al.</i> (1995) Patil <i>et al.</i> (2008) Sengupta <i>et al.</i> (2003) Szławska <i>et al.</i> (2009) Szytuła <i>et al.</i> (1993) Benesovsky <i>et al.</i> (1966) Binder (1960) | 621958 164827 106425 |
| Si | i | 8.3270 8.2370 8.2300 8.2240 8.2620 4.1900 4.2700 4.1415 | | 8.4391 8.5160 8.4450 8.4400 4.2261 8.4390 13.9300 13.8800 13.7816 | 1.0253 1.0227 1.0253 1.0255 0.5139 1.0214 3.3246 3.2506 3.3277 | 8 8 8 4 8 4 4 4 4 | $E_{r_2}RhSi_3$ $E_{r_2}RhSi_3$ ($P\overline{6}2c$) $E_{r_2}RhSi_3$ (190/194) $E_{r_2}RhSi_3$ (190/194) Ce_2CoSi_3/U_2RuSi_3 $E_{r_2}RhSi_3$ ($P\overline{6}2c$) $ThSi_2$ $ThSi_2$ $ThSi_2$ | - 730°C, 4 days 800°C, 5 days 800°C, 5 days - 800°C, 54 days - | Chevalier <i>et al.</i> (1984) Kase <i>et al.</i> (2009) Leciejewicz <i>et al.</i> (1995) Patil <i>et al.</i> (2008) Sengupta <i>et al.</i> (2003) Szlawska <i>et al.</i> (2009) Szytuła <i>et al.</i> (2009) Szytuła <i>et al.</i> (1993) Benesovsky <i>et al.</i> (1966) Binder (1960) Brauer & Haag (1950) | 621958 164827 106425 622204 |
| Si | i | 8.3270 8.2370 8.2300 8.2240 8.2620 4.1900 4.2700 4.1415 4.1560 | | 8.4391 8.5160 8.4450 8.4400 4.2261 8.4390 13.9300 13.8800 13.7816 13.8400 | 1.0253 1.0227 1.0253 1.0255 0.5139 1.0214 3.3246 3.2506 3.3277 3.3301 | 8 8 8 4 4 4 4 4 | Er_2RhSi_3 Er_2RhSi_3 ($P\overline{6}2c$) Er_2RhSi_3 (190/194) Er_2RhSi_3 (190/194) Cc_2CoSi_3/U_2RuSi_3 Er_2RhSi_3 ($P\overline{6}2c$) $ThSi_2$ $ThSi_3$ $ThSi_2$ $ThSi_3$ | - 730°C, 4 days 800°C, 5 days 800°C, 5 days - 800°C, 54 days - - | Chevalier <i>et al.</i> (1984) Kase <i>et al.</i> (2009) Leciejewicz <i>et al.</i> (1995) Patil <i>et al.</i> (2008) Sengupta <i>et al.</i> (2003) Szlawska <i>et al.</i> (2009) Szytuła <i>et al.</i> (2009) Szytuła <i>et al.</i> (1993) Benesovsky <i>et al.</i> (1966) Binder (1960) Brauer & Haag (1950) Brauer & Haag (1952) | 621958 164827 106425 622204 25664 |
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| S | i | 8.3270 8.2370 8.2370 8.2240 4.1900 4.2700 4.1415 4.1560 4.1760 4.1910 4.1900 4.1900 4.2700 4.1900 4.1900 4.1900 4.2700 4.1900 | | 8.4391 8.5160 8.4450 4.2261 8.4490 13.9300 13.8800 13.8800 13.8890 13.9300 13.8800 13.9300 13.8800 13.8800 13.8200 13.8200 13.8200 13.8200 | 1.0253 1.0227 1.0255 0.5139 1.0214 3.3246 3.3250 3.3277 3.3301 3.3140 3.3214 3.3246 3.3126 3.3126 3.3126 3.3120 3.3230 3.3230 3.3230 3.3241 3.3222 3.2506 | 8 8 8 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 | Er_2RhSi_3 Er_2RhSi_3 ($P\overline{6}2c$) Er_2RhSi_3 (190/194) Er_2RhSi_3 (190/194) Er_2RhSi_3 (190/194) Ce_2CoSi_3/U_2RuSi_3 Er_2RhSi_3 ($P\overline{6}2c$) $ThSi_2$ $ThSi_2$ $ThSi_2$ $ThSi_2$ $ThSi_2$ - $ThSi_2$ - $ThSi_3$ - $ThSi_$ | 730°C, 4 days 800°C, 5 days 800°C, 5 days - - - - - - - - - - - - - - - - - - - | Chevalier et al. (1984) Kase et al. (2009) Leciejewicz et al. (1995) Patil et al. (2008) Sengupta et al. (2009) Szlawska et al. (2009) Szytuła et al. (2009) Szytuła et al. (1993) Benesovsky et al. (1966) Binder (1960) Brauer & Haag (1950) Brauer & Haag (1952) Dhar et al. (1987) Dhar et al. (1987) Dijkman et al. (1987) Dijkman et al. (1982) Houssay et al. (1989) Lahiouel et al. (1986) Lawrence et al. (1984) Mayer et al. (1967) Mayer & Eshdat (1968) Murashita et al. (1991) Perri et al. (1959b) Bierre et al. (1988) | 621958 164827 106425 622204 25664 622206 622197 622190 622153 |
| S | i | 8.3270 8.2370 8.2370 8.2240 8.2620 4.1900 4.1900 4.1900 4.1910 4.1900 4.1900 4.1900 4.2700 4.1900 4.2700 4.1900 4.2700 4.1900 4.1500 | | 8.4391 8.5160 8.4450 4.2261 8.4390 13.9300 13.8800 13.8800 13.8480 13.8480 13.8480 13.9300 13.8800 13.9300 13.8800 13.8200 13.8200 13.8200 13.8200 13.9200 | 1.0253 1.0227 1.0253 1.0255 0.5139 1.0214 3.3246 3.32506 3.3277 3.3301 3.3140 3.3214 3.3246 3.3126 3.3126 3.3220 3.3230 3.3214 3.3220 3.3220 3.3222 3.2506 3.3222 3.3222 3.3222 | 8 8 8 4 4 4 4 4 4 4 4 4 4 4 4 4 | Er_2RhSi_3 Er_2RhSi_3 ($P\overline{6}2c$) Er_2RhSi_3 (190/194) Er_2RhSi_3 (190/194) Ce_2CoSi_3/U_2RuSi_3 Er_2RhSi_3 ($P\overline{6}2c$) $ThSi_2$ $ThSi_2$ $ThSi_2$ $ThSi_2$ $ThSi_2$ -like $ThSi_2$ -like $ThSi_2$ -defect $ThSi_2$ $ThSi_2$ -defect or $Nd\Box_xSi_{2-x}$ $ThSi_2$ $ThSi_3$ ThS | 730°C, 4 days 800°C, 5 days 800°C, 5 days 800°C, 5 days - - - - - - - - - - - - - - - - - - - | Chevalier et al. (1984) Kase et al. (2009) Leciejewicz et al. (1995) Patil et al. (2008) Sengupta et al. (2003) Szlawska et al. (2009) Szytuła et al. (1993) Benesovsky et al. (1966) Binder (1960) Brauer & Haag (1950) Brauer & Haag (1952) Dhar et al. (1987) Dhar et al. (1987) Dijkman et al. (1982) Houssay et al. (1988) Lahiouel et al. (1986) Lawrence et al. (1984) Mayer et al. (1967) Mayer & Eshdat (1968) Murashita et al. (1991) Perri et al. (195b) Pierre et al. (1988) Paman & Steinfink (1967) | 621958 164827 106425 622204 25664 622206 622197 622190 622153 |
| S | i | 8.3270 8.2370 8.2370 8.2240 8.2620 4.1900 4.1900 4.1910 4.1910 4.1900 4.1900 4.1900 4.2700 4.1900 4.2700 4.1900 4.2700 4.1900 4.2700 4.1900 | | 84391 8.5160 8.4450 8.4400 4.2261 8.4390 13.9300 13.8800 13.8800 13.8400 13.8400 13.8400 13.8400 13.8800 13.8800 13.8200 13.8200 13.8200 13.8200 13.8200 13.8200 13.8200 13.8200 | 1.0253 1.0227 1.0253 1.0255 0.5139 1.0214 3.3246 3.32506 3.3277 3.3301 3.3161 3.3140 3.3214 3.3226 3.3220 3.3220 3.3220 3.3222 3.3226 3.3222 3.3422 | 8 8 8 4 4 4 4 4 4 4 4 4 4 4 4 4 | Er_2RhSi_3 Er_2RhSi_3 ($P\overline{6}2c$) Er_2RhSi_3 (190/194) Er_2RhSi_3 (190/194) Ce_2CoSi_3/U_2RuSi_3 Er_2RhSi_3 ($P\overline{6}2c$) $ThSi_2$ $ThSi_2$ $ThSi_2$ $ThSi_2$ $ThSi_2$ -like $ThSi_2$ -defect $ThSi_2$ -defect $ThSi_2$ $ThSi_2$ -defect or $Nd\Box_xSi_{2-x}$ $ThSi_2$ $ThSi_3$ T | 730°C, 4 days 800°C, 5 days 800°C, 5 days - - - - - - - - - - - - - - - - - - - | Chevalier et al. (1984) Kase et al. (2009) Leciejewicz et al. (1995) Patil et al. (2008) Sengupta et al. (2003) Szlawska et al. (2009) Szytuła et al. (1993) Benesovsky et al. (1966) Binder (1960) Brauer & Haag (1950) Brauer & Haag (1952) Dhar et al. (1987) Dhar et al. (1987) Dijkman et al. (1982) Houssay et al. (1989) Lahiouel et al. (1986) Lawrence et al. (1984) Mayer et al. (1967) Mayer & Eshdat (1968) Murashita et al. (1991) Perri et al. (1959b) Pierre et al. (1988) Raman & Steinfink (1967) Buggiero & Olcese (1964) | 621958 164827 106425 622204 25664 622206 622197 622190 622153 |

| R | Т | a (Å) | b (Å) | c (Å) | c/a | Formula units | Structure type | Thermal treatment | Reference | ICSD number |
|----------|----------|------------------|-----------|------------------|--------|------------------|--|---------------------------|---|------------------|
| | | 4.1880 | 4.1180 | 13.8800 | 3.3142 | 4 | $Nd \square _{x}Si_{2-x}$ | 1000°C, 3 days | Shaheen & Schilling (1987) | 622192 |
| | | 4.1910 | | 13.9490 | 3.3283 | 4 | ThSi ₂ | 1000°C, 3 days | Shaheen & Schilling (1987) | 622192 |
| | | 4.1890 | | 13.8920 | 3.3163 | 4 | ThSi ₂ | - | Weitzer et al. (1991) | 622175 |
| | | 4.1840 | | 13.8560 | 3.3117 | 4 | ThSi ₂ | - | Yashima <i>et al.</i> (1982 <i>c</i>) | 21642 |
| Cm | Si | 4.1600 | | 13,7200 | 3.3413 | 4 | ThSi ₂ ThSi ₂ | _ | Weigel & Marguart (1983) | 31042 |
| Dv | Ni | 3.9700 | | 4.0130 | 1.0108 | 1 | AlB ₂ | _ | Mayer & Felner (1973b) | 53369 |
| -) | Pd | 8.1110 | | 8.0550 | 0.9931 | 8 | h | _ | Kotsanidis <i>et al.</i> (1990) | |
| | | 4.0620 | | 4.0310 | 0.9924 | 1 | AlB ₂ | 750°C, 10 days | Li et al. (2003) | |
| | | 4.0620 | | 4.0310 | 0.9924 | 1 | AlB ₂ | 750°C, 10 days | Nimori & Li (2006) | |
| | D4 | 4.0612 | | 4.0334 | 0.9932 | 1 | AlB_2 En PhS: (\overline{DG}_2) | 750° C, 5 days | Szytuła <i>et al.</i> (1999) | |
| | Pt Rh | 8.1000 | | 8.2000 | 1.0123 | 8 | Er_2RnSl_3 (P02C) Er RhSi | $900^{\circ}C$, 25 days | L1 et al. (2013) Chevelier et al. (1984) | 630163 |
| | Si | 4.0400 | 3.9500 | 13.3300 | 3.2995 | 4 | GdSi ₂ | | Binder (1960) | 050105 |
| | | 3.8300 | | 4.1100 | 1.0731 | 1 | AlB ₂ | _ | Gladyshevskii (1963) | 20248 |
| | | 3.8310 | | 4.1210 | 1.0757 | 1 | AlB ₂ | 700°C, 3 days | Iandelli et al. (1979) | 630294 |
| | | 3.8285 | 6.6312 | 4.1230 | 1.0769 | 2 | $Er_3 \square Si_5$ | 1000°C, 10 days | Ji <i>et al.</i> (2004) | |
| | | 6.6338 | 6 6255 | 4.1200 | 0.6211 | 3 | $Yb_3 \square Sl_5$ | - | Knapp & Picraux (1985) | 52292 |
| | | 3.8300 | 0.0555 | 4.1210 | 1.0757 | 2 | $\square 3 \square 3 \square 5 $ | - 450°C 0.5 days | Maver et al. (1967) | 103369 |
| | | 4.0450 | 3.9350 | 13.3190 | 3.2927 | 4 | GdSi ₂ | | Mayer & Eshdat (1968) | 630287 |
| | | 4.0300 | 3.9300 | 13.3200 | 3.3052 | 4 | GdSi ₂ | _ | Mayer & Eshdat (1968) | |
| | | 4.0300 | 3.9310 | 13.3200 | 3.3052 | 4 | GdSi ₂ | - | Mayer & Felner (1973b) | |
| | | 3.9739 | 2 0 5 0 0 | 13.6760 | 3.4415 | 4 | ThSi ₂ | - | Nesper <i>et al.</i> (1979) | 630314 |
| | | 4.0400 | 3.9500 | 13.3400 | 3.3020 | 4 | GdSi ₂ | - | Perri <i>et al.</i> $(1959b)$ | 630297 |
| | | 4.0300 | 3 9500 | 13,3300 | 3 2995 | 4 | GdSia | _ | Perri $et al.$ (1959 a) | 630297 |
| | | 4.0380 | 3.9370 | 13.3100 | 3.2962 | 4 | GdSi ₂ | _ | Pierre <i>et al.</i> (1988) | 030277 |
| Er | Cu | 3.9670 | | 13.7300 | 3.4611 | 4 | ThSi ₂ | - | Raman (1967) | 627257 |
| | Ni | 3.9600 | | 3.9860 | 1.0066 | 1 | AlB ₂ | - | Mayer & Felner (1973b) | 53404 |
| | Pd | 4.0640 | | 3.9910 | 0.9820 | 1 | h | Floating zone | Frontzek (2009) | |
| | | 8.0920 | | 7.9250 | 0.9/94 | 8 | h AlD | - 750°C 5 down | Kotsanidis <i>et al.</i> (1990) | |
| | Rh | 4.0427 | | 3.9794 8 7480 | 1.0829 | 8 | Ald ₂ FraRhSia | 800° C 4 days | Bazela et al. (1999) | 97376 |
| | 1 cm | 8.0780 | | 7.7480 | 0.9591 | 8 | Er_2RhSi_3 (<i>P</i> 62 <i>c</i>) | 800°C, 4 days | Bazela <i>et al.</i> (2003) | 97375 |
| | | 8.0360 | | 7.7120 | 0.9597 | 8 | Er_2RhSi_3 (P62c) | 800°C, 4 days | Chevalier et al. (1984) | 53413 |
| | | 8.1130 | | 7.7556 | 0.9559 | 8 | Er ₂ RhSi ₃ | 800°C, 14 days | Gladyshevskii et al. (1992) | 300248 |
| | Si | 3.7930 | 6.5697 | 4.0820 | 1.0762 | 2 | $Er_3 \square Si_5$ | - | Auffret et al. (1990) | 20250 |
| | | 3.7990 | | 4.0890 | 1.0764 | 1 | AIB ₂ | - 700°C 3 dava | Gladyshevskii (1963) | 20250 |
| | | 3,7980 | 6 5801 | 4.0880 | 1.0765 | 2 | Fr_{2} | $1000^{\circ}C_{10}$ days | $\begin{array}{c} \text{Iandem et al.} (1979) \\ \text{Ii et al.} (2004) \end{array}$ | 031140 |
| | | 6.5818 | 0.0001 | 4.0900 | 0.6214 | 3 | Yb ₃ DSi ₅ | | Knapp & Picraux (1985) | |
| | | 3.7990 | 6.5801 | 4.0900 | 1.0766 | 2 | Er ₃ DSi ₅ | - | Koleshko et al. (1986) | 631159 |
| | | 3.7800 | | 4.0900 | 1.0820 | 1 | AlB ₂ | - | Mayer et al. (1962) | 631151 |
| | | 3.7800 | | 4.0800 | 1.0794 | 1 | AlB ₂ | 450°C, 0.5 days | Mayer <i>et al.</i> (1967) | 631140 |
| | | 3.7850 | | 4.0800 | 1.07/9 | 1 | AIB ₂ | 700° C, 2 days | Mayer & Felner (1972) Mayer & Felner (1973b) | 631144 |
| | | 3,9370 | | 4.0900 | 3 4585 | 4 | ThSi ₂ | _ | Nesper <i>et al.</i> (1979) | 631164 |
| | | 3.7920 | | 4.0830 | 1.0767 | 1 | AlB ₂ | _ | Pierre <i>et al.</i> (1988) | 631150 |
| | | 3.8000 | | 4.0900 | 1.0763 | 1 | AlB ₂ | _ | Sekizawa & Yasukouchi (1966) | 631155 |
| | | 6.5783 | | 8.1760 | 1.2429 | 6 | $Tb_3 \square Si_5$ | 700°C, 0 days | Tsai et al. (2005) | |
| Eu | Ag | 8.4200 | 14.8580 | 17.8640 | 2.1216 | 16 | Ba ₄ Li ₂ Si ₆ | 900°C, 3 days | Cardoso Gil et al. (1999) | 410521 |
| | | 4.1500 | 0.0260 | 4.5150 | 1.0880 | 1 | AIB_2 | - 800°C 5 dava | Mayer & Felner $(19/3a)$ | 58453 |
| | Co | 8.3000 4.0460 | 9.0509 | 14.5770 | 1.7509 | 0 1 | Ca ₂ AgSi ₃ | 800 C, 5 days | Sarkar et ul. (2015) Mayer & Felner (1973a) | 230324 |
| | Cu | 4.0762 | | 4.4895 | 1.1014 | 1 | AlB ₂ -like | - Floating zone | Cao <i>et al.</i> $(2010, 2011)$ | 102379 |
| | °. | 8.1890 | | 8.9760 | 1.0961 | 8 | Er_2RhSi_3 (190/194) | 800°C, | Majumdar <i>et al.</i> (1998) | |
| | | 4.0950 | | 4.4880 | 1.0960 | 1 | AlB ₂ | - | Majumdar et al. (1999b) | |
| | | 4.0800 | | 4.4660 | 1.0946 | 1 | AlB ₂ | - | Mayer & Felner (1973a) | 53255 |
| | Ni | 4.0340 | | 4.4960 | 1.1145 | 1 | AlB ₂ | - 7500 C 7 Jan | Mayer & Felner $(1973a)$ | 53436 |
| | Pa Si | 8.3188 | | 4.5588 | 0.5240 | 4 | Ce_2COSI_3/U_2RUSI_3 | /50°C, / days | Rodewald <i>et al.</i> (2003) Binder (1960) | 591240 631674 |
| | 51 | 4.3040 | | 13.6500 | 3.1715 | 4 | ThSi ₂ | _ | Evers <i>et al.</i> $(1977a)$ | 1454 |
| | | 4.3030 | | 13.6600 | 3.1745 | 4 | ThSi ₂ | _ | Evers <i>et al.</i> (1983) | |
| | | 4.0520 | | 4.4820 | 1.1061 | 1 | AlB ₂ | - | Nesper et al. (1979) | 103436 |
| | | 4.2970 | | 13.7040 | 3.1892 | 4 | ThSi ₂ | - | Nesper et al. (1979) | 631683 |
| <u> </u> | р. | 4.2900 | | 13.6600 | 3.1841 | 4 | t L | - Flaat: | Perri <i>et al.</i> (1959b) | |
| Gd | Pd | 4.0790 | | 4.0980 | 1.0047 | 1 | n h | Floating zone | Frontzek (2009) Kotsopidis <i>et al.</i> (1000) | |
| | Pt | 8.1390 | | 8.3030 | 1.0201 | 8 | // Er₂RhSi₂ (190/194) | 750°C, 14 days | Majumdar <i>et al.</i> (2001) | |
| | Rh | 8.1120 | | 7.9760 | 0.9832 | 8 | Er ₂ RhSi ₃ | 800°C, 4 days | Chevalier et al. (1984) | 636281 |

| | | | | | | Formula | Structure | Thermal | | ICSD |
|----|----------|---------|--------|---------|--------|---------|--|--------------------------|--|---------|
| R | Т | a (Å) | b (Å) | c (Å) | c/a | units | type | treatment | Reference | number |
| | | 8 11 20 | | 7 0760 | 0.0832 | 8 | Er DhSi | | Mulder at al. (1008) | |
| | c; | 4.0020 | 4.0130 | 13 /370 | 3 2837 | 4 | | = 800°C 1 day | Auffret at al. (1998) | |
| | 51 | 4.0920 | 4.0100 | 13,4400 | 3 2861 | 4 | $GdSi_{2-x}$ | 500 C, 1 day | Binder (1960) | |
| | | 4.0200 | 4 1000 | 13,4300 | 3 3408 | 4 | Nd Sie | - 800°C 1 day | Houssay <i>et al.</i> (1989) | 636419 |
| | | 3 8770 | 4.1000 | 4 1720 | 1 0761 | 1 | AlB_2 | 700° C 3 days | Iandelli <i>et al.</i> (1939) | 636432 |
| | | 6.7204 | | 4.1700 | 0.6205 | 3 | Yb ₂ Si ₅ | | Knapp & Picraux (1985) | 050152 |
| | | 3.8770 | 6.7152 | 4.1720 | 1.0761 | 2 | Er ₂ Si ₅ | _ | Koleshko <i>et al.</i> (1986) | 53633 |
| | | 3.8700 | | 4.1700 | 1.0775 | 1 | AlBa | 450°C, 0.5 days | Mayer <i>et al.</i> (1967) | 636421 |
| | | 4.0800 | 4.0100 | 13.4200 | 3.2892 | 4 | GdSi ₂ | _ | Mayer & Eshdat (1968) | |
| | | 3.8690 | 6.7013 | 4.1820 | 1.0809 | 2 | Er ₃ Si ₅ | 800°C, 14 days | Mulder et al. (1994) | 658032 |
| | | 3.8525 | | 4.1470 | 1.0764 | 1 | AlB ₂ | _ | Nesper <i>et al.</i> (1979) | 636450 |
| | | 4.0438 | | 13.8020 | 3.4131 | 4 | ThSi ₂ | - | Nesper et al. (1979) | 636452 |
| | | 4.1000 | 4.0100 | 13.6100 | 3.3195 | 4 | 0 | - | Perri et al. (1959b) | 150661 |
| | | 4.0900 | 4.0100 | 13.4400 | 3.2861 | 4 | GdSi ₂ | - | Perri et al. (1959a) | |
| | | 4.0900 | 4.0100 | 13.4400 | 3.2861 | 4 | GdSi ₂ | - | Pierre et al. (1988) | 636434 |
| | | 4.0930 | 4.0090 | 13.4400 | 3.2837 | 4 | $Nd\Box_xSi_{2-x}$ | - | Pierre et al. (1990) | |
| | | 4.0800 | 3.9960 | 13.4100 | 3.2868 | 4 | GdSi ₂ | 1000°C, 4 days | Raman & Steinfink (1967) | |
| | | 4.0900 | 4.0100 | 13.4200 | 3.2812 | 4 | GdSi ₂ | - | Sekizawa & Yasukouchi (1966) | 636440 |
| Ho | Pd | 8.1520 | | 32.1680 | 3.9460 | 32 | h | Floating zone | Frontzek (2009) | |
| | | 8.1010 | | 7.9960 | 0.9870 | 8 | h | 750°C, 5 days | Kotsanidis et al. (1990) | |
| | | 8.0994 | | 32.0192 | 3.9533 | 32 | h | Floating zone | Leisegang (2010) | |
| | | 8.1072 | | 8.1072 | 1.0000 | 8 | Er_2RhSi_3 (190/194) | 800°C, 7 days | Mo <i>et al.</i> (2015) | 192586 |
| | | 4.0459 | | 3.9977 | 0.9881 | 1 | AlB ₂ | 750°C, 5 days | Szytuła et al. (1999) | |
| | | 8.1000 | | 32.0000 | 3.9506 | 32 | Ho ₂ PdSi ₃ | Floating zone | Tang <i>et al.</i> (2011) | |
| | | 4.0460 | | 3.9977 | 0.9881 | 4 | Ce_2CoSi_3/U_2RuSi_3 | 750°C, 5 days | Zajdel <i>et al.</i> (2015) | |
| | Rh | 8.0860 | | 7.8040 | 0.9651 | 8 | Er ₂ RhSi ₃ | 800°C, 4 days | Bazela <i>et al.</i> (2003) | 97374 |
| | | 8.0860 | | 7.8040 | 0.9651 | 8 | Er_2RhSi_3 (P62c) | 800°C, 4 days | Bazela <i>et al.</i> (2003) | 97373 |
| | <u>.</u> | 8.0720 | 6 5030 | 7.7/10 | 0.9627 | 8 | Er ₂ RhSi ₃ | 800° C, 4 days | Chevalier <i>et al.</i> (1984) | 639636 |
| | Sı | 3.8070 | 6.5939 | 4.1060 | 1.0785 | 2 | $Er_3 \square S1_5$ | 800°C, 1 day | Auffret et al. (1991) | |
| | | 4.0290 | 3.91/0 | 13.2770 | 3.2954 | 4 | $\operatorname{Nd}_{x}\operatorname{Sl}_{2-x}$ | 800°C, 1 day | Auffret <i>et al.</i> (1991) | |
| | | 3.8087 | 0.5909 | 4.1050 | 1.0773 | 2 | $Er_3 \sqcup Sl_5$ | 1100°C, 8 days | Eremenko <i>et al.</i> (1995) | |
| | | 4.0250 | 5.9140 | 15.2620 | 3.3013 | 4 | $\operatorname{Nu}_{x}\operatorname{Sl}_{2-x}$ | 1100 C, 8 days | Cladushavskii (1963) | 20240 |
| | | 3.8160 | | 4.1070 | 1.0703 | 1 | | - 700°C 3 days | Jandelli <i>et al.</i> (1903) | 630720 |
| | | 3.8100 | 6 5001 | 4.1070 | 1.0703 | 2 | AiD_2 Er \Box Si | 1000° C 10 days | $\begin{array}{c} \text{Indem et ut. (1979)} \\ \text{Ii et al. (2004)} \end{array}$ | 039729 |
| | | 6 5001 | 0.3991 | 4.1055 | 0.6228 | 2 | | 1000 C, 10 days | $K_{nann} \& Picraux (1985)$ | |
| | | 3 8160 | 6 6095 | 4 1070 | 1.0763 | 2 | | 2 | Koleshko <i>et al.</i> (1986) | 639748 |
| | | 4.0300 | 3 9700 | 13 3100 | 3 3027 | 2 | 0 | _ | Mayer <i>et al.</i> (1962) | 057740 |
| | | 3 8000 | 5.9700 | 4 1000 | 1 0789 | 1 | AlBa | 450° C 0.5 days | Mayer <i>et al.</i> (1962) | 56250 |
| | | 3.9610 | | 13,6450 | 3,4448 | 4 | ThSia | - | Nesper <i>et al.</i> (1979) | 639750 |
| | | 4.0150 | 3.9060 | 13.2200 | 3.2927 | 4 | GdSi2 | _ | Pierre $et al.$ (1988) | 639731 |
| | | 3.9900 | 3.9400 | 13.3000 | 3.3333 | 4 | GdSi ₂ | _ | Sekizawa & Yasukouchi (1966) | 639743 |
| | | 4.0280 | 3.9120 | 13.2870 | 3.2987 | 4 | GdSi ₂ | _ | Weitzer et al. (1991) | |
| | | 4.0100 | 3.9120 | 13.2550 | 3.3055 | 4 | GdSi ₂ | - | Weitzer et al. (1991) | |
| La | Al | 4.3030 | | 14.2100 | 3.3023 | 4 | ThSi ₂ | 1000°C, 4 days | Raman & Steinfink (1967) | |
| | Со | 4.1880 | | 4.3660 | 1.0425 | 1 | AlB ₂ | - | Bodak & Gladyshevskii (1985) | |
| | | 8.1850 | | 4.3500 | 0.5315 | 4 | Ce2CoSi3/U2RuSi3 | 750°C, 7 days | Majumdar et al. (1999a) | |
| | Cu | 4.0840 | | 4.3950 | 1.0762 | 1 | AlB_2 | - | Hwang et al. (1996) | |
| | | 4.1440 | | 4.2860 | 1.0343 | 1 | AlB ₂ | - | Raman (1967) | 103037 |
| | | 4.0710 | | 4.3830 | 1.0766 | 1 | AlB ₂ | - | Raman (1967) | |
| | _ | 4.0840 | | 4.3950 | 1.0762 | 1 | AlB ₂ | - | Tien <i>et al.</i> (1997) | |
| | Fe | 4.0800 | | 4.3500 | 1.0662 | 1 | AlB ₂ | - | Bodak & Gladyshevskii (1985) | |
| | | 4.0690 | | 4.1010 | 1.0079 | 1 | AlB ₂ | - | Raman (1967) | |
| | | 4.09/0 | | 4.3310 | 1.0571 | 1 | AlB ₂ | - | Raman (1967) | |
| | N1 | 4.0930 | | 4.3540 | 1.0638 | 1 | AlB ₂ | - | Bodak & Gladyshevskii (1985) | 20205 |
| | | 4.0770 | | 4.3670 | 1.0/11 | 1 | AlB ₂ | - | Gladyshevskii & Bodak (1965) | 20305 |
| | | 4.0450 | | 4.3810 | 1.0831 | 1 | | 700° C, 2 days | Mayer & Feiner (1972) | 041574 |
| | | 4.0770 | | 4.5000 | 1.034/ | 1 | | - | Raman (1967) | |
| | | 4.0370 | | 4.3000 | 1.0010 | 1 | | - 200°C 7 days | Raman (1907) Resident al. (2010) | |
| | | 4 0680 | | 4 3753 | 1.0743 | 1 1 | AIR. | | Szlawska & Kaczorowski (2012) | |
| | Pt | 8 2000 | | 4 4170 | 0.5328 | 1 4 | Ce.CoSi./U.RuSi | 750°C 14 dave | Majumdar et al. (2001) | |
| | Rh | 8 2330 | | 8 5940 | 1 0438 | 8 | EraRhSia | $800^{\circ}C$ 4 days | Chevalier <i>et al.</i> (1984) | 641751 |
| | 1 MI | 8,2800 | | 8.6500 | 1.0447 | 8 | Er_2RhSi_2 (190/194) | 800° C 5 days | Sengupta <i>et al.</i> (2003) | 011/31 |
| | Si | 4.3700 | | 13.5600 | 3,1030 | 4 | ThSi2 | | Bertaut & Blum (1950) | 174010 |
| | 51 | 4.3100 | | 13.2800 | 3.0812 | 4 | ThSi2 | _ | Binder (1960) | 1, 1010 |
| | | 4.2612 | | 13.7118 | 3.2178 | 4 | ThSi ₂ | _ | Brauer & Haag (1950) | 641982 |
| | | 4.2810 | | 13.7500 | 3.2119 | 4 | ThSi2 | _ | Brauer & Haag (1952) | 25663 |
| | | 4.3300 | | 13.8300 | 3.1940 | 4 | ThSi ₂ -defect | 800°C, 1 dav | Houssay et al. (1989) | 641955 |
| | | 4.3100 | | 13.8000 | 3.2019 | 4 | ThSi ₂ | - | Lawrence et al. (1984) | 641973 |
| | | 4.1900 | 4.2700 | 13.9400 | 3.3270 | 4 | GdSi ₂ | 450°C, 0.5 days | Mayer et al. (1967) | 641958 |

| R | Т | a (Å) | b (Å) | c (Å) | c/a | Formula units | Structure type | Thermal treatment | Reference | ICSD number |
|-------------|-------------|------------------|--------|---------|---------|------------------|---|---------------------------|--|-----------------|
| | | 4.2900 | | 13.8700 | 3.2331 | 4 | ThSi ₂ | _ | Mayer & Eshdat (1968) | 641961 |
| | | 4.3260 | | 13.8400 | 3.1993 | 4 | ThSi ₂ | - | Nakano & Yamanaka (1994) | 78028 |
| | | 4.3100 | | 13.8000 | 3.2019 | 4 | t | - | Perri et al. (1959b) | |
| | | 4.3000 | | 13.8400 | 3.2186 | 4 | ThSi ₂ | - | Pierre et al. (1988) | |
| _ | _ | 4.3050 | | 13.8400 | 3.2149 | 4 | ThSi ₂ | 1000° C, 4 days | Raman & Steinfink (1967) | |
| Lu | Pd | 4.0267 | | 3.9218 | 0.9739 | 1 | AlB ₂ | Floating zone | Cao <i>et al.</i> (2013, 2014) | 250596, 250597 |
| | Sı | 3.7450 | | 4.0500 | 1.0814 | 1 | AIB ₂ | - | Gladyshevskii (1963) | 20253 |
| | | 5./4/0 6.4052 | | 4.0460 | 1.0/98 | 1 | AIB ₂ Vh = S: | 700° C, 3 days | Landelli <i>et al.</i> (1979) | 642610 |
| | | 0.4952 3 7450 | 6 1865 | 4.0300 | 0.0255 | 2 | $I U_3 \sqcup SI_5$ | - | Kilapp & Picraux (1985) | 642613 |
| | | 3 7400 | 0.4805 | 4.0300 | 1.0814 | 1 | | _ | Mayer <i>et al.</i> (1960) | 642611 |
| | | 3,7500 | | 4.0500 | 1.08002 | 1 | AlBa | 450°C 0.5 days | Mayer et al. (1962) | 642.607 |
| Nd | Ag | 4.1750 | | 14.3100 | 3.4275 | 4 | ThSi ₂ | | Mayer & Felner (1973b) | 605613 |
| | Cu | 8.0760 | | 8.4400 | 1.0451 | 8 | Er ₂ RhSi ₃ (190/194) | 800°C, 7 days | Yubuta et al. (2009) | |
| | Ni | 4.0420 | | 4.1630 | 1.0299 | 1 | AlB ₂ | - | Gladyshevskii & Bodak (1965) | 20307 |
| | | 4.0130 | | 4.2020 | 1.0471 | 1 | AlB ₂ | 700°C, 2 days | Mayer & Felner (1972) | 76594 |
| | | 4.0200 | | 4.2070 | 1.0465 | 1 | AlB ₂ | - | Mayer & Felner (1973b) | 645635 |
| | Pd | 8.1970 | | 8.4020 | 1.0250 | 8 | h | 750°C, 5 days | Kotsanidis et al. (1990) | |
| | | 4.1050 | | 4.2040 | 1.0241 | 1 | AlB_2 | 750°C, 10 days | Li et al. (2003) | |
| | | 4.1033 | | 4.2039 | 1.0245 | 1 | AlB_2 | 750°C, 5 days | Szytuła et al. (1999) | |
| | Pt | 4.0927 | | 4.2582 | 1.0404 | 1 | AlB ₂ | 900°C, 23 days | Li et al. (2001) | |
| | | 8.2170 | | 4.2820 | 0.5211 | 4 | Ce ₂ CoSi ₃ /U ₂ RuSi ₃ | 750°C, 14 days | Majumdar <i>et al.</i> (2001) | |
| | Rh | 8.1860 | | 8.2720 | 1.0105 | 8 | Er_2RhSi_3 | 800°C, 4 days | Chevalier <i>et al.</i> (1984) | 645781 |
| | C : | 8.1710 | 4 1500 | 8.2760 | 1.0129 | 8 | Er_2RhSi_3 (P62c) | 800° C, 54 days | Szytuła <i>et al.</i> (1993) | 57432 |
| | 51 | 4.1800 | 4.1500 | 13.5000 | 3.2440 | 4 | | - | Binder (1960) | 645097 |
| | | 4.1010 | | 13.4223 | 3.2723 | 4 | | - | Brauer & Haag (1950) Brouer & Haag (1952) | 043987 |
| | | 4.1110 | 4 2000 | 13.5000 | 3.2903 | 4 | Ndo Si | = 800°C 1 day | Housson at al (1980) | 23000 645041 |
| | | 4.1000 | 4.2000 | 13,5600 | 3 2440 | 4 | $GdSi_{2}$ | | Lawrence et al. (1984) | 043941 |
| | | 4 1700 | 4 1300 | 13,6500 | 3 2734 | 4 | GdSia | 450° C 0.5 days | Mayer <i>et al.</i> (1967) | 645948 |
| | | 4.1800 | 4.1600 | 13.6300 | 3.2608 | 4 | GdSi2 | | Mayer & Eshdat (1968) | 010010 |
| | | 4.1800 | 4.1500 | 13.5600 | 3.2440 | 4 | GdSi ₂ | _ | Mayer & Felner (1973b) | |
| | | 4.1650 | | 13.6420 | 3.2754 | 4 | GdSi ₂ | _ | Nesper <i>et al.</i> (1979) | 645989 |
| | | 4.1110 | | 13.5600 | 3.2985 | 4 | ThSi ₂ | - | Perri et al. (1959b) | 645972 |
| | | 4.1740 | 4.1540 | 13.6100 | 3.2607 | 4 | GdSi ₂ | - | Pierre et al. (1988) | 645963 |
| | | 3.9480 | 6.8381 | 4.2690 | 1.0813 | 2 | $Er_3 \square Si_5$ | - | Pierre et al. (1990) | |
| | | 4.1350 | 4.1010 | 13.7400 | 3.3229 | 4 | $Nd\Box_xSi_{2-x}$ | - | Pierre et al. (1990) | |
| | | 4.1470 | 4.1250 | 13.6700 | 3.2964 | 4 | $Nd\Box_xSi_{2-x}$ | - | Pierre et al. (1990) | |
| | | 4.1620 | | 13.5800 | 3.2629 | 4 | ThSi ₂ | 1000°C, 4 days | Raman & Steinfink (1967) | 645949 |
| | | 4.1620 | | 13.5800 | 3.2629 | 4 | ThSi ₂ | - | Raman (1968) | 645985 |
| | <u>.</u> | 4.1850 | 4.1600 | 13.6100 | 3.2521 | 4 | GdS12 | 1050° C, 10 days | Schobinger-Papamantellos <i>et al.</i> (1991) | (55) (15) |
| Np | 51 | 3.9680 | | 13./150 | 3.4564 | 4 | | - | Yaar et al. (1992) | 65/64/ |
| D., | C 12 | 3.9700 | | 13.7000 | 3.4509 | 4 | | - | Zacharlasen (1949) Tion et el (1997) | 31044 |
| F1 | Cu | 4.0320 | | 4.2350 | 1.0301 | 1 | | - 000°C 20 days | Wong at $al (2014)$ | |
| | Ni | 4.0420 | | 4.2050 | 1.0403 | 1 | AlB. | 900 C, 20 days | Gladyshevskij & Bodak (1965) | 20306 |
| | 141 | 4 0210 | | 4.0250 | 1.0447 | 1 | AlB ₂ | _ | Mayer & Felner (1973b) | 646272 |
| | Pd | 8.2210 | | 8.4660 | 1.0298 | 8 | h | 750°C, 5 days | Kotsanidis <i>et al.</i> (1990) | 010272 |
| | | 4.0250 | | 4.2070 | 1.0452 | 1 | AlB ₂ | Floating zone | Xu et al. (2010) | |
| | Pt | 8.2300 | | 4.3000 | 0.5225 | 4 | Ce2CoSi3/U2RuSi3 | 750°C, 14 days | Majumdar et al. (2001) | |
| | Si | 4.2000 | | 13.7600 | 3.2762 | 4 | ThSi ₂ | - | Binder (1960) | 649371 |
| | | 4.2100 | | 13.7300 | 3.2613 | 4 | ThSi2-defect | 800°C, 5 days | Boutarek et al. (1994) | 658012 |
| | | 4.1315 | | 13.4922 | 3.2657 | 4 | ThSi ₂ | - | Brauer & Haag (1950) | |
| | | 4.1480 | | 13.6700 | 3.2956 | 4 | ThSi ₂ | - | Brauer & Haag (1952) | 25665 |
| | | 4.2100 | | 13.7300 | 3.2613 | 4 | ThSi ₂ -defect | 800°C, 1 day | Houssay et al. (1989) | 649364 |
| | | 4.2900 | | 13.7600 | 3.2075 | 4 | ThSi ₂ | - | Lawrence et al. (1984) | |
| | | 4.1700 | 4.1200 | 13.8200 | 3.3141 | 4 | GdSi ₂ | 450°C, 0.5 days | Mayer <i>et al.</i> (1967) | 649365 |
| | | 4.1600 | | 13.7600 | 3.3077 | 4 | ThSi ₂ | - | Mayer & Eshdat (1968) | |
| | | 4.2900 | | 13.7600 | 3.2075 | 4 | | - | Mayer & Felner $(1973b)$ | (4027) |
| | | 4.2000 | | 12,7600 | 3.2762 | 4 | | - | Perri et al. $(1959b)$ | 049370 |
| | | 4.2000 | | 13,7200 | 3.2/02 | + 1 | ThSi | _ | $\begin{array}{c} 1 \text{ cm} (17370) \\ \textbf{Pierre at al} (1088) \\ \end{array}$ | |
| | | 4 2000 | | 13,7300 | 3 2600 | → 4 | ThSig-defect | | Pierre $\rho t al (1990)$ | |
| P 11 | Si | 3 9670 | | 13 7200 | 3 4585 | 4 | ThSi2 | _ | Coffinherry & Ellinger (1955) | 649973 |
| ıч | 51 | 3,8750 | 6.7117 | 4.1020 | 1.0586 | 2 | Er2 Sie | 840°C 42 days | Land <i>et al.</i> (1965) | 517713 |
| | | 3,9680 | 5./11/ | 13.7100 | 3,4551 | 4 | ThSi2 | | Land et al. (1965) | 649969 |
| | | 3.8840 | | 4.0820 | 1.0510 | 1 | AlB ₂ | _ | Runnals & Boucher (1955) | 44867 |
| | | 3.9800 | | 13.5800 | 3.4121 | 4 | ThSi ₂ | _ | Zachariasen (1949) | 31645 |
| Sc | Si | 3.6600 | 6.3393 | 3.8700 | 1.0574 | 2 | $Er_3 \Box Si_5$ | - | Gladyshevskii & Émes-Misenko (1963) | |
| | | 3.6600 | 6.3393 | 3.8700 | 1.0574 | 2 | Er ₃ DSi ₅ | - | Koleshko et al. (1986) | 651822 |
| | | 3.6620 | 6.3428 | 3.8790 | 1.0593 | 2 | $Er_3 \square Si_5$ | - | Kotroczo & McColm (1994) | |

| | | . • . | . • . | . • . | | Formula | Structure | Thermal | | ICSD |
|-------|-----------|--------|--------|------------------|------------------|---------|---|-------------------------|---|--------|
| R | Т | a (A) | b(A) | <i>c</i> (A) | c/a | units | type | treatment | Reference | number |
| | | 3.6620 | 6.3428 | 3.8790 | 1.0593 | 2 | Er₂⊐Sia | _ | Kotroczo & McColm (1994) | 657975 |
| | | 3,6600 | 0.0120 | 3.8700 | 1.0574 | 1 | AlB | _ | Nörenberg <i>et al.</i> (2006) | 051715 |
| Sm | Ni | 4.0020 | | 4.1600 | 1.0395 | 1 | AlBa | _ | Gladyshevskii & Bodak (1965) | 20308 |
| | Si | 4.1050 | 4.0350 | 13.4600 | 3.2789 | 4 | GdSi ₂ | _ | Binder (1960) | |
| | | 4.0417 | | 13.3126 | 3.2938 | 4 | ThSi ₂ | - | Brauer & Haag (1950) | |
| | | 4.0490 | | 13.3600 | 3.2996 | 4 | ThSi ₂ | - | Brauer & Haag (1952) | 25667 |
| | | 4.1100 | 4.0600 | 13.4900 | 3.2822 | 4 | GdSi ₂ | - | Mayer & Eshdat (1968) | 652268 |
| | | 4.1050 | 4.0350 | 13.4600 | 3.2789 | 4 | 0 | - | Perri et al. (1959b) | 652273 |
| | | 4.0800 | | 13.5100 | 3.3113 | 4 | ThSi ₂ | - | Perri et al. (1959b) | 652274 |
| | | 4.1040 | 4.0350 | 13.4600 | 3.2797 | 4 | GdSi ₂ | - | Perri et al. (1959a) | |
| Sr | Au | 8.3407 | 9.2664 | 14.4465 | 1.7320 | 8 | Ca ₂ AgSi ₃ | 650°C, 7 days | Zeiringer et al. (2015) | |
| | Ni | 4.0690 | | 4.6630 | 1.1460 | 1 | AlB ₂ | - | Bodak & Gladyshevskii (1968) | 20301 |
| | Si | 4.4380 | | 13.8300 | 3.1163 | 4 | | - | Evers <i>et al.</i> $(197/a)$ | 1455 |
| | 51 | 4.4380 | | 12.8300 | 3.1103 | 4 | | - | Evers et al. (1978b) Balanzana & Bani (2004) | 00228 |
| | | 4.4290 | | 13.8420 | 3.1235 | 4 | ThSi | - | Palenzona & Pani (2004) | 99238 |
| Th | Pd | 4.4390 | | 10.000 | 0.0073 | + 1 | h | – Floating zone | Frontzek (2009) | |
| 10 | Iu | 8 1210 | | 8 1000 | 0.9974 | 8 | h | 750°C 5 days | Kotsanidis <i>et al.</i> (1990) | |
| | | 4.0650 | | 4.0520 | 0.9968 | 1 | AlBa | 750°C 10 days | Li <i>et al.</i> (2003) | |
| | | 4.0643 | | 4.0502 | 0.9965 | 1 | AlB ₂ | 750°C, 5 days | Szytuła $et al.$ (1999) | |
| | Pt | 8.1223 | | 8.2368 | 1.0141 | 8 | Er_2RhSi_3 (P62c) | 900°C, 23 days | Li <i>et al.</i> (2002 <i>a</i>) | |
| | Rh | 8.1100 | | 7.8600 | 0.9692 | 8 | Er ₂ RhSi ₃ | 800°C, 4 days | Chevalier et al. (1984) | 650328 |
| | | 8.1400 | | 7.8120 | 0.9597 | 8 | $\operatorname{Er}_{2}\operatorname{RhSi}_{3}(P\overline{6}2c)$ | 800°C, 54 days | Szytuła et al. (1993) | 57483 |
| | Si | 3.8460 | 6.6615 | 4.1430 | 1.0772 | 2 | $Er_3 \square Si_5$ | 800°C, 1 day | Auffret et al. (1991) | |
| | | 4.0570 | 3.9650 | 13.3770 | 3.2973 | 4 | $Nd\Box_x Si_{2-x}$ | 800°C, 1 day | Auffret et al. (1991) | |
| | | 3.8470 | | 4.1460 | 1.0777 | 1 | AlB ₂ | - | Gladyshevskii (1963) | 20247 |
| | | 3.8470 | | 4.1460 | 1.0777 | 1 | AlB ₂ | 700°C, 3 days | Iandelli et al. (1979) | 652359 |
| | | 6.6684 | | 4.1500 | 0.6223 | 3 | Yb ₃ □Si ₅ | - | Knapp & Picraux (1985) | |
| | | 3.8470 | 6.6632 | 4.1460 | 1.0777 | 2 | $Er_3 \square Si_5$ | - | Koleshko <i>et al.</i> (1986) | 652375 |
| | | 4.0450 | 3.9600 | 13.3800 | 3.3078 | 4 | | - 450%C 0.5 Jam | Mayer <i>et al.</i> (1962) | (50254 |
| | | 3.8400 | 4.0500 | 4.1400 | 2 2799 | 1 | Alb ₂ | 430 C, 0.5 days | Mayer & Eshdet (1068) | 652355 |
| | | 3.9000 | 4.0500 | 13.5600 | 3.3700 | 4 | | _ | Nesper at al (1900) | 652377 |
| | | 4 0500 | 3 9650 | 13 3600 | 3 2988 | 4 | GdSia | _ | Pierre et al. (1979) | 652360 |
| | | 4.0400 | 3.9600 | 13.3900 | 3.3144 | 4 | GdSia | _ | Sekizawa & Yasukouchi (1966) | 652370 |
| Th | Au | 4.1972 | 217000 | 14.3030 | 3.4077 | 4 | ThSi ₂ | 800°C, 7 davs | Albering <i>et al.</i> (1994) | 658096 |
| | Co | 4.0520 | | 4.1510 | 1.0244 | 1 | AlB ₂ | 800°C, 7 days | Albering et al. (1994) | 658085 |
| | | 4.0430 | | 4.1890 | 1.0361 | 1 | AlB2 | 950°C, 8 days | Zhong et al. (1985) | 53078 |
| | Cu | 4.0230 | | 4.1910 | 1.0418 | 1 | AlB ₂ | 800°C, 7 days | Albering et al. (1994) | 108410 |
| | Fe | 4.0993 | | 14.1850 | 3.4603 | 4 | ThSi ₂ | 800°C, 7 days | Albering et al. (1994) | 658089 |
| | Ir | 4.1366 | | 14.3640 | 3.4724 | 4 | ThSi ₂ | 800°C, 7 days | Albering et al. (1994) | 658094 |
| | | 4.1200 | | 14.3100 | 3.4733 | 4 | ThSi ₂ | - | Lejay et al. (1983), Chevalier et al. (1986) | |
| | Mn | 4.1069 | | 14.1130 | 3.4364 | 4 | ThSi ₂ | 800°C, 7 days | Albering et al. (1994) | 658088 |
| | N1 | 4.0322 | | 4.1891 | 1.0389 | 1 | AlB ₂ | 800°C, 7 days | Albering <i>et al.</i> (1994) | 54299 |
| | Os D-i | 4.1384 | | 14.3/84 | 3.4/44 | 4 | | 800° C, / days | Albering <i>et al.</i> (1994) | 658093 |
| | Pa Dt | 4.1570 | | 14.2820 | 3.4357 | 4 | | 800° C, 7 days | Albering <i>et al.</i> (1994) | 658092 |
| | Rh | 4.1392 | | 14.2850 | 3 4885 | 4 | ThSi ₂ | 800° C, 7 days | Albering et al. (1994) | 658093 |
| | m | 4 1100 | | 14.3200 | 3 4842 | 4 | ThSia | | Leiav et al. (1983) Chevalier et al. (1986) | 050071 |
| | Ru | 4.1242 | | 14.4470 | 3.5030 | 4 | ThSi ₂ | 800°C, 7 davs | Albering <i>et al.</i> (1994) | 658090 |
| | Si | 4.1180 | | 14.2210 | 3.4534 | 4 | ThSi ₂ | _ | Benesovsky <i>et al.</i> (1966) | |
| | | 4.1340 | | 14.3750 | 3.4773 | 4 | ThSi ₂ | _ | Brauer & Mittius (1942) | 77320 |
| | | 4.1260 | | 14.3460 | 3.4770 | 4 | ThSi ₂ | - | Brauer & Mittius (1942) | 660234 |
| | | 4.1360 | | 4.1260 | 0.9976 | 1 | AlB ₂ | - | Brown & Norreys (1959) | |
| | | 3.9850 | 6.9022 | 4.2280 | 1.0610 | 2 | $Er_3 \Box Si_5$ | - | Brown & Norreys (1959) | |
| | | 4.1360 | | 4.1260 | 0.9976 | 1 | AlB ₂ | - | Brown (1961) | 15449 |
| | | 4.1350 | | 14.3750 | 3.4764 | 4 | ThSi ₂ | - | Brown (1961) | 652390 |
| | | 3.9850 | | 4.2200 | 1.0590 | 1 | AlB ₂ | - 0500C 0 1 | Jacobson <i>et al.</i> (1956) | 26569 |
| т | ЪJ | 4.1270 | | 14.1940 | 3.4393 0.0796 | 4 | 1 n S1 ₂ | 950°C, 8 days | Znong et al. (1985) | |
| 1 111 | гu | 4.0370 | | 5.9700 7.8500 | 0.9780 | 1 | n h | 750°C 5 dave | FIGHTZER (2009) Kotsopidis at al. (1000) | |
| | Si | 3,7730 | | 4.0700 | 1.0787 | 1 | AlBa | | Gladysheyskii (1963) | 20251 |
| | 51 | 3.7680 | | 4.0700 | 1.0801 | 1 | AlBa | 700°C, 3 days | Iandelli <i>et al.</i> (1979) | 52468 |
| | | 6.5298 | | 4.0700 | 0.6233 | 3 | $Yb_3 \square Si_5$ | | Knapp & Picraux (1985) | . = |
| | | 3.7730 | 6.5350 | 4.0700 | 1.0787 | 2 | Er3DSi5 | - | Koleshko et al. (1986) | 604540 |
| | | 3.7600 | | 4.0700 | 1.0824 | 1 | AlB ₂ | - | Mayer et al. (1962) | 652455 |
| | | 3.7700 | | 4.0700 | 1.0796 | 1 | AlB ₂ | 450°C, 0.5 days | Mayer et al. (1967) | 652451 |
| U | Au | 4.1450 | | 3.9890 | 0.9624 | 1 | AlB ₂ | 800°C, 60 days | Chevalier et al. (1996) | |
| | | 4.1450 | | 3.9890 | 0.9624 | 1 | AlB ₂ | 800°C, 8 days | Pöttgen & Kaczorowski (1993) | 106295 |
| | Со | 3.9870 | | 3.8830 | 0.9739 | 1 | AlB ₂ | 800°C, 60 days | Chevalier et al. (1996) | 10000 |
| | | 3.9880 | | 3.8830 | 0.9737 | 1 | AlB ₂ | 800°C, 10 days | Kaczorowski & Noël (1993) | 106494 |

| R | Т | a (Å) | b (Å) | c (Å) | c/a | Formula units | Structure type | Thermal treatment | Reference | ICSD number |
|---|----------|-------------------------|--------|-------------------|--------|------------------|---|--|--|------------------|
| | | 3.9880 | | 3.8830 | 0.9737 | 1 | AlB ₂ | 800°C, 8 days | Pöttgen & Kaczorowski (1993) | |
| | | 3.9765 | | 3.8980 | 0.9803 | 1 | AlB ₂ | - | Szlawska et al. (2011) | |
| | Cu | 3.9710 | | 13.9260 | 3.5069 | 4 | ThSi ₂ | 800°C, 10 days | Kaczorowski & Noël (1993) | 603112 |
| | | 4.0090 | | 3.9570 | 0.9870 | 1 | AIB ₂ ThSi | 600° C, 49 days | Pechev <i>et al.</i> (2000) Pöttgen & Kaczorowski (1003) | 92357 |
| | Fe | 4 0030 | | 3 8570 | 0.9635 | 4 | AlB ₂ | 800° C, 8 days 800° C, 60 days | Chevalier <i>et al.</i> (1996) | 002804 |
| | 10 | 4.0040 | | 3.8640 | 0.9650 | 1 | AlB ₂ | 800°C, 10 days | Kaczorowski & Noël (1993) | 603109 |
| | | 4.0100 | | 3.8400 | 0.9576 | 1 | AlB ₂ | 800°C, 7 days | Lourdes Pinto (1966) | 53551 |
| | | 4.0040 | | 3.8640 | 0.9650 | 1 | AlB ₂ | 800°C, 8 days | Pöttgen & Kaczorowski (1993) | |
| | | 8.0030 | | 3.8540 | 0.4816 | 4 | Ce ₂ CoSi ₃ /U ₂ RuSi ₃ | 800°C, 10 days | Yamamura <i>et al.</i> (2006) | |
| | Ir | 4.0650 | | 3.9140 | 0.9629 | 1 | AlB ₂ | 800°C, 60 days | Chevalier <i>et al.</i> (1996) | 57200 |
| | | 4.0720 | | 3.0320 | 0.9303 | 1 | AID ₂ AIB -like | 800° C, 8 days | $\frac{1}{2} \sum_{k=1}^{n} \frac{1}{2} \left(\frac{2006}{2} \right)$ | 37398 |
| | | 4.0900 | | 3.8540 | 0.9423 | 1 | AlB ₂ -like | 800°C, 7 days | Yubuta et al. (2006) | |
| | Mn | 8.0450 | | 3.8082 | 0.4734 | 4 | Ce ₂ CoSi ₃ /U ₂ RuSi ₃ | 800°C, 60 days | Chevalier <i>et al.</i> (1996) | |
| | Ni | 3.9790 | | 3.9460 | 0.9917 | 1 | AlB ₂ | 800°C, 60 days | Chevalier et al. (1996) | |
| | | 3.9790 | | 3.9490 | 0.9925 | 1 | AlB ₂ | 800°C, 10 days | Kaczorowski & Noël (1993) | 54300 |
| | | 3.9790 | | 3.9490 | 0.9925 | 1 | AlB ₂ | 800°C, 8 days | Pöttgen & Kaczorowski (1993) | |
| | Oc | 3.9/20 8 1600 | | 3.9461 | 0.9935 | 1 | AIB_2 | - 800°C 60 dava | Schröder <i>et al.</i> (1995) | |
| | Os | 4.0666 | | 3.8440 | 0.4711 | 4 | ΔIB_2 | 800° C, 8° days | Pottgen & Kaczorowski (1993) | 57453 54310 |
| | | 8.1600 | | 3.8440 | 0.4711 | 4 | Ce ₂ CoSi ₃ /U ₂ RuSi ₃ | 800°C, 60 days | Pöttgen <i>et al.</i> (1994) | 57455, 54510 |
| | Pd | 4.0800 | 7.0670 | 3.9390 | 0.9654 | 2 | U ₂ RhSi ₃ | 800°C, 60 days | Chevalier et al. (1996) | 57172 |
| | | 4.0830 | | 3.9320 | 0.9630 | 1 | AlB ₂ | 800°C, 3 days | Li et al. (1998b) | |
| | _ | 4.0850 | | 3.9350 | 0.9633 | 1 | AlB ₂ | 800°C, 8 days | Pöttgen & Kaczorowski (1993) | 57467 |
| | Pt | 4.0730 | | 3.9650 | 0.9735 | 1 | AlB ₂ | 800°C, 60 days | Chevalier <i>et al.</i> (1996) | |
| | | 4.0840 | | 3.9730 | 0.9728 | 1 | | $800^{\circ}C$, 10 days | Kaczorowski & Noel (1993) | |
| | | 4.0670 | | 3.9640 | 0.9747 | 1 | AlB ₂ | 800°C, 10 days | Pöttgen & Kaczorowski (1993) | 602802 |
| | | 4.0840 | | 3.9730 | 0.9728 | 1 | AlB ₂ | 850°C, 5 days | Sato <i>et al.</i> (1991) | 54345 |
| | | 4.0840 | | 3.9730 | 0.9728 | 1 | AlB ₂ | - | Sato et al. (1992) | |
| | | 4.0730 | | 3.9600 | 0.9723 | 1 | AlB ₂ | 800°C, 10 days | Yamamura et al. (2006) | |
| | Rh | 4.0620 | 7.0360 | 3.9290 | 0.9673 | 2 | U_2 RhSi ₃ | 800°C, 60 days | Chevalier <i>et al.</i> (1996) | 57171 |
| | | 4.0740 | | 3.8810 | 0.9526 | 1 | | $800^{\circ}C$, 3 days | Li et al. (1999) Pöttgen & Kaczorowski (1993) | 57485 |
| | | 4.0700 8.1011 | | 3.9477 | 0.4873 | 4 | Ce ₂ CoSi ₂ | - | Szlawska <i>et al.</i> (2016) | 57485 |
| | Ru | 8.1480 | | 3.8550 | 0.4731 | 4 | Ce ₂ CoSi ₃ /U ₂ RuSi ₃ | 800°C, 60 days | Chevalier <i>et al.</i> (1996) | |
| | | 4.0750 | | 3.8380 | 0.9418 | 1 | AlB ₂ | 800°C, 8 days | Pöttgen & Kaczorowski (1993) | 108727 |
| | | 8.1450 | | 3.8496 | 0.4726 | 4 | Ce2CoSi3/U2RuSi3 | 800°C, 60 days | Pöttgen et al. (1994) | 78530 |
| | <u>.</u> | 8.1480 | | 3.8550 | 0.4731 | 4 | Ce ₂ CoSi ₃ /U ₂ RuSi ₃ | 800°C, 60 days | Pöttgen et al. (1994) | |
| | S1 | 3.8600 | | 4.0700 | 1.0544 | 1 | AIB ₂ | _ | Benesovsky <i>et al.</i> (1966) | |
| | | 3.8520 | | 4 0280 | 1 0457 | 4 | | _ | Brown & Norreys (1959) | 652472 52469 |
| | | 3.8430 | 6.6563 | 4.0690 | 1.0588 | 2 | Er ₂ Si ₅ | _ | Brown & Norreys (1959) | 052472, 52405 |
| | | 3.8520 | | 4.0280 | 1.0457 | 1 | AlB ₂ | 650°C | Brown & Norreys (1961) | |
| | | 3.8430 | 6.6563 | 4.0690 | 1.0588 | 2 | $Er_3 \square Si_5$ | 650°C | Brown & Norreys (1961) | |
| | | 3.8390 | | 4.0720 | 1.0607 | 1 | AlB ₂ | - | Dwight (1982) | 106053 |
| | | 3.8390 | | 4.7200 | 1.2295 | 1 | AIB ₂ | - | Dwight (1982) | 652476 |
| | | 3.9220 | | 4 0700 | 3.0089 | 4 | | 2 | Sasa & Oda (1970) Zachariasen (1949) | 205 |
| | | 3.9800 | | 13,7400 | 3.4523 | 4 | ThSi ₂ | _ | Zachariasen (1949) | 31643 |
| Y | Pd | 8.1380 | | 8.0410 | 0.9881 | 8 | h | 750°C, 5 days | Kotsanidis <i>et al.</i> (1990) | |
| | | 8.0910 | | 8.0920 | 1.0001 | 8 | Er ₂ RhSi ₃ (190/194) | 750°C, 7 days | Mallik & Sampathkumaran (1996) | |
| | Pt | 8.0990 | | 8.1940 | 1.0117 | 8 | Er ₂ RhSi ₃ (190/194) | 750°C, 14 days | Majumdar et al. (2001) | |
| | Rh | 8.0860 | | 7.8290 | 0.9682 | 8 | Er_2RhSi_3 | 800°C, 4 days | Chevalier <i>et al.</i> (1984) | 650353 |
| | c; | 8.1300 | 6 6511 | 7.8800 | 0.9692 | 8 | Er_2RhSi_3 (190/194) | 800° C, 5 days | Sengupta <i>et al.</i> (2003) | |
| | 31 | 5.8400 6.6511 | 0.0311 | 4.1400 | 0.6225 | 2 | $\Sigma_{13} \sqcup S_{15}$ $Y_{b_2} \Box S_{15}$ | _ | Baptist <i>et al.</i> (1988) Baptist <i>et al.</i> (1990) | |
| | | 4.0400 | 3.9500 | 13.3300 | 3.2995 | 4 | GdSi2 | _ | Binder (1960) | |
| | | 3.8420 | 6.6545 | 4.1400 | 1.0776 | 2 | $Er_3 \Box \tilde{Si}_5$ | - | Gladyshevskii & Émes-Misenko (1963) | |
| | | 3.8415 | 6.6537 | 4.1425 | 1.0784 | 2 | $Er_3 \square Si_5$ | 1000°C, 10 days | Ji et al. (2004) | |
| | | 6.6511 | | 4.1400 | 0.6225 | 3 | $Yb_3 \Box Si_5$ | - | Knapp & Picraux (1985) | 650500 |
| | | 3.8420 3.8392 | 0.6545 | 4.1400 | 1.07/6 | 2 | $Er_3 \square Sl_5$ | - | Koleshko et al. (1986) Kotur & Mokra (1994) | 652588 658006 |
| | | <i>3.6363</i> 4.0500 | 3 9500 | +.1310 13 2200 | 3 2642 | 1 4 | GdSia | _ | Lazorenko <i>et al.</i> (1974) | 652570 |
| | | 3.8500 | 5.7500 | 4.1400 | 1.0753 | 1 | AlB ₂ | _ | Mayer <i>et al.</i> (1962) | 652584 |
| | | 4.0500 | 3.9500 | 13.4000 | 3.3086 | 4 | 0 | - | Mayer <i>et al.</i> (1962) | |
| | | 3.8300 | | 4.1400 | 1.0809 | 1 | AlB ₂ | 450°C, 0.5 days | Mayer et al. (1967) | 652566 |
| | | 3.8430 | 0.0500 | 4.1430 | 1.0781 | 1 | AlB ₂ | 800°C, 2 days | Mayer & Felner (1972) | 52478 |
| | | 4.0400 | 3.9500 | 13.2300 | 3.2748 | 4 | GdS12 | - | Perri <i>et al.</i> $(1959b)$ | 652582 |
| | | 4.0400 | | 15.4200 | 3.3218 | 4 | 111312 | - | reiii ei ai. (19390) | 130002 |

Table 1 (continued)

| R | Т | a (Å) | b (Å) | c (Å) | c/a | Formula units | Structure type | Thermal treatment | Reference | ICSD number |
|----|----|--------|---------|---------|--------|------------------|---|-------------------|---------------------------|----------------|
| | | 4.0400 | 3.9500 | 13.3300 | 3.2995 | 4 | GdSi ₂ | _ | Perri et al. (1959a) | |
| Yb | Au | 8.2003 | 14.1870 | 16.8690 | 2.0571 | 16 | Ba ₄ Li ₂ Si ₆ | 800°C, 5 days | Sarkar et al. (2013) | 250525 |
| | Si | 3.7710 | | 4.0980 | 1.0867 | 1 | AlB ₂ | _ | Gladyshevskii (1963) | 20252 |
| | | 3.7840 | | 4.0980 | 1.0830 | 1 | AlB_2 | 700°C, 3 days | Iandelli et al. (1979) | 52480 |
| | | 6.5120 | | 4.0900 | 0.6281 | 3 | Yb ₃ □Si ₅ | 700°C, 3 days | Iandelli et al. (1979) | |
| | | 6.5472 | | 4.1000 | 0.6262 | 3 | Yb ₃ □Si ₅ | - | Knapp & Picraux (1985) | |
| | | 3.7710 | 6.5316 | 4.0980 | 1.0867 | 2 | Er ₃ DSi ₅ | - | Koleshko et al. (1986) | 652601 |
| | | 3.7700 | | 4.1000 | 1.0875 | 1 | AlB ₂ | - | Mayer et al. (1962) | 652598 |
| | | 3.7610 | | 4.0920 | 1.0880 | 1 | AlB ₂ | - | Nesper et al. (1979) | 652603 |
| | | 3.9868 | | 13.5410 | 3.3965 | 4 | ThSi ₂ | 850°C, 3 days | Peter & Kanatzidis (2012) | |
| | | 6.5120 | | 4.0900 | 0.6281 | 3 | Yb ₃ DSi ₅ | 700°C, 21 days | Pöttgen et al. (1998) | |

the scope of this work. The phase diagrams given by Bodak & Gladyshevskii (1985) are not at room temperature.

3.1. Structural relationships

The many structure types within compounds RSi_2 and R_2TSi_3 compounds are related to each other according to their space groups and occupied Wyckoff positions. Starting from the highest symmetric structure, different perturbations induce symmetry reductions. Bärnighausen diagrams are the perfect tool to visualize these group–subgroup relationships in a simple and descriptive way. Fig. 1 presents the full Bärnighausen diagram for the RSi_2 and R_2TSi_3 compounds analyzed in this work. This diagram is partially based on a diagram by Hoffmann & Pöttgen (2001), but is greatly extended.

The presented Bärnighausen diagram would allow for further group–subgroup transitions; thus the authors cannot exclude the existence of further structure types within the RSi_2 and R_2TSi_3 compounds and thus also additional branches in the diagram. However, the space groups we present here already have a high number of free parameters. The extension of the diagram by further symmetry reduction accompanied with further degrees of freedom without losing the rough lattice and symmetry is challenging.

Our diagram provides information about the type of transition (klassengleiche with perpetuation of lattice symmetry, translationengleiche with perpetuation of translational symmetry and isomorphous with perpetuation of both), the change of the lattice (direction and distance), the characteristics of the structure (space group, structure type and Wyckoff positions) as well as the absolute occurrence of the structure types in the literature. Additionally, Fig. 2 visualizes the atom arrangements of the different structures and presents their relationships in a hierarchical structure similar to the Bärnighausen diagram. In contrast, it focuses on the structural models and only shows these branches that include new structure types compared to Hoffmann & Pöttgen (2001). Appendix A includes tables with Wyckoff positions of all structure types taken into account within this article (Tables 2, 3, 4, 5, 6, 7, 8, 9, 10, 11, 12, 13, 14, 15, 16 and 17).

3.1.1. Compounds deduced from the AlB₂ structure type. First, we will present the relationships of RSi_2 and R_2TSi_3 compounds derived from the AlB₂ structure. The lattice parameters are in the range of $a_h \approx 3.8-4.2$ Å and $c_h \approx 3.9-4.5$ Å, which is much higher than for the parent structure AlB₂ itself ($a_{AlB_2} = 3.00$ Å, $c_{AlB_2} = 3.24$ Å).

Hoffmann & Pöttgen (2001) gave an overview of the hexagonal and orthorhombic transitions of AlB₂-related compounds. Only three of Hoffmann's Bärnighausen branches are applicable for the stoichiometries addressed here (RSi_2 and R_2TSi_3). We identify further structure types not discussed by Hoffmann & Pöttgen (2001), analyze the relationships of all structure types in the following paragraphs and show the new structure types in the Bärnighausen diagram (Fig. 2). Our Bärnighausen diagram (Fig. 2) thus exhibits four main branches which result from interactions with a T element or an Si vacancy \Box .

The first branch of the Bärnighausen diagram describes the symmetrical relationships between the hexagonal derivatives of the AlB₂ type. Fig. 2 shows that Ce₂CoSi₃ (Gordon et al., 1997) has the same structural motif as the aristotype. The difference is the ordering of the T atoms resulting in isolated [Si₆] rings, see top right of Fig. 2. Only a certain part of this pattern is visible in the unit cell of Ce₂CoSi₃ and in other structure types of the RSi_2 and R_2TSi_3 compounds, indicated by red bonds. Besides $[Si_6]$ rings, $[T_2Si_4]$ hexagons also occur, with the T atoms opposing each other in the ring. This ordering change indicates the doubling of the unit-cell parameter a in the Ce₂CoSi₃ type and an *isomorphous* symmetry reduction. If the Si atoms are shifted along the c direction, the layers are no longer perfectly planar, but puckered. This arrangement can be described with the same space group as Ce₂CoSi₃, but with half-occupied Wyckoff site 12*o*, instead of fully occupied 6m, known as the structure type U₂RuSi₃ (Pöttgen et al., 1994). Fig. 2 shows both structure types within one subfigure with the different Si positions indicated by a series of atoms.

Compared to their ideal crystallographic positions, the Er_2RhSi_3 (*P*6₃/*mmc*) type (Gladyshevskii *et al.*, 1992) exhibits shifts of the *T* atoms along the *c* direction accompanied by distortions of the *R* atoms centering the [*T*₂Si₄] rings. This puckering results in a doubling of the *c* parameter and thus a



Bärnighausen diagram for RSi₂ and R₂TSi₃ compounds. The header of each box comprises the Hermann–Mauguin symbol of the space group, the range of ordering n and the structure type, whereas the body contains the occupied Wyckoff sites sorted by element. The arrows display the type of transformation between the structures: *t* is *translationengleich*, *k* is *klassengleich* and *i* is isomorphic. Fig. 2 comprises the respective structures plots. The fourth branch of AlB₂-like compounds comprises the superstructures caused by interplays with vacancies ($R_3 \square Si_3$). A potential tetragonal superstructure is presented in the right-hand part of the diagram.

Figure 1

further *klassengleiche* reduction of the symmetry of the Ce₂CoSi₃ or U₂RuSi₃ type. The reported noncentrosymmetric structure for Er₂RhSi₃ ($P\overline{6}2c$) (Chevalier *et al.*, 1984) assumes additional distortions of the [Si₆] rings and their centering *R* atoms by decoupled *x* and *y* coordinates resulting in a *translationengleiche* symmetry reduction of centrosymmetric Er₂RhSi₃ ($P\overline{6}_3/mmc$).

The second branch only includes the Ho_2PdSi_3 structure type (Tang *et al.*, 2011) with monoclinic space group *I*112/*b*

(Nentwich *et al.*, 2016). This structure contains eight Si/*T* layers with stacking sequence *ABCDBADC*. Each layer exhibits the same Si/*T* occupation pattern as the Ce₂CoSi₃ type. The $[T_2Si_4]$ rings of adjacent layers are shifted and rotated by multiples of 60° around the *c* axis with respect to each other. The 12-fold coordinated *R* elements are located on two different Wyckoff positions, either coordinated by two $[T_2Si_4]$ rings or by one $[T_2Si_4]$ ring and one $[Si_6]$ ring. The Ho₂PdSi₃ type contains 32 subcells and is thus one of the



Figure 2

Models of the different observed structure types within RSi_2 and R_2TSi_3 compounds (unit cell outlined in black). The AlB₂-like structures are depicted such that the view onto the two-dimensional R network is almost identical. The common structure pattern of the ordered AlB₂-like structures (gray frame at right top) is highlighted with a light-gray frame and red Si/T bonds. The structure types Ce₂CoSi₃ and U₂RuSi₃ are almost identical. In contrast to the U₂RuSi₃ type, the Si atoms of the Ce₂CoSi₃ type are on the highly symmetric $z = \frac{1}{2}$ position. This is highlighted by the blurred Si location along the cdirection. The tetragonal structures (gray frame at center top) compose a 3D Si/T subnetwork with incomplete hexagons at the faces (highlighted in orange). The structures are connected according to their symmetry relations (dashed lines, if the transition is not minimal; labels comprise the lattice transformation).

largest structures within the AlB_2 Bärnighausen diagram. The atoms are assumed to be on the ideal crystallographic position, without any distortions, although the space group would allow this. The transition from AlB_2 type to Ho_2PdSi_3 involves several symmetry reduction steps, detailed in Fig. 1.

The third branch comprises the orthorhombic derivatives of the AlB₂ type. The starting point for further reductions is an orthohexagonal setting with space group *Cmmm* and Wyckoff sequence 2*a*, 4*k*. This setting is still a missing link (Hoffmann & Pöttgen, 2001), meaning that no report about a compound with this structure has been found. This space group has independent lattice parameters *a* and *b* – in contrast to all previous structure types – causing a *translationengleiche* symmetry reduction and making it an important starting point for five further structure types.

One of them is $Ba_4Li_2Si_6$ (von Schnering *et al.*, 1996), which has perfectly ordered Si/T layers with the same occupational pattern as the Ce₂CoSi₃ type. As in the Ho₂PdSi₃ structure type, the Si/T atoms are perfectly ordered and form an *ABCD* stacking sequence, which is consistent with the two differently coordinated *R* sites as mentioned before. Accompanied with the anisotropic available space of the *R* site surrounded by one [T_2Si_4] and one [Si₆] ring, its *z* component is not on the ideal crystallographic position resulting in a puckering of the *R* and Si/T layers. Identical *R* elements are connected along the former hexagonal *a* direction. These structural changes are accompanied with three consecutive *klassengleiche* symmetry reductions doubling the *a* and *b* parameters and quadrupling the *c* parameter.

A second structure type is U₂RhSi₃ (Pöttgen & Kaczorowski, 1993) with space group Pmmm (No. 47). Its Si/T atoms are partially ordered and only shifted along the b direction. These shifts induce a break in translational symmetry and a klassengleiche reduction. The Ho2PdSi3, Ba4Li2Si6 and Ca₂AgSi₃ structure types (Gordon et al., 1997) have perfectly ordered Si/T layers and the same local arrangements around the R atoms. The R elements of the same Wyckoff site are connected along the orthorhombic a direction. These structural changes indicate the doubling of lattice parameters and a klassengleiche transition from structure type U₂RhSi₃. Hoffmann & Pöttgen (2001) have already reported a second structure type with the same space group as U₂RhSi₃, but with a different Wyckoff sequence, namely Er₃ Si₅. This type represents the disordered nonstoichiometric disilicides. In addition to the disordered ones, we also found reports about ordered versions. The otherwise very detailed review by Hoffmann & Pöttgen (2001) did not discuss these variants, which form due to vacancy ordering. According to the real stoichiometry of RSi_{1.67}, one Si atom is regularly missing in the Si hexagons (Roge et al., 1995). This arrangement can be realized by a hexagonal and a orthohexagonal setting (Auffret et al., 1990). The hexagonal setting will be discussed in the fourth branch. The orthohexagonal arrangement requires a triplication of the *a* parameter. We will refer to this setting as Ho₃ Si₅ type. We prepared a list of its atomic parameters in space group P1 (No. 1) and inserted it to the software FINDSYM (Stokes & Hatch, 2005), which determined the highest possible space group as Pmm2 (No. 25). We changed the setting to P2mm (No. 25) for a better comparability to its supergroup Pmmm (No. 47). Thus, the triplication causes a *translationengleiche* and a *klassengleiche* symmetry reduction, which is accompanied with potential shifts of all atoms within the *a,b* plane.

The fourth branch comprises the ordered $R_3 \square Si_5$ structures, which are not related to the disordered $Er_3 \square Si_5$ type within the Bärnighausen diagram.

d'Avitaya *et al.* (1989) described a $\sqrt{3} \times \sqrt{3}$ low-energy electron diffraction (LEED) pattern of Er₃ \square Si₅ thin films. Iandelli *et al.* (1979) determined the space group of this arrangement for Yb₃ \square Si₅ as $P\overline{62m}$ (No. 189), only allowing the *x* parameter of *R* and Si to deviate from its ideal crystallographic position. To consider the underlying symmetries of this arrangement, the cell needs to be enlarged and rotated with respect to the AlB₂ unit cell using an *isomorphous* symmetry reduction. The location of the vacancy on an independent Wyckoff site is accompanied by a further *translationengleiche* symmetry reduction and an origin shift from space group *P6/mmm* to $P\overline{62m}$.

Another model proposed by Stauffer *et al.* (1992) is based on the aforementioned arrangement, but every second Si/*T* layer is rotated by 120° around *c*. We determined the space group of this vacancy ordering as $P\overline{62}c$, assuming that only the occupational pattern of the Si lattice would adapt, without changing the atomic positions. This results in a doubling of the *c* parameter, accompanied by a *klassengleiche* transition. The first reports concerning this arrangements used the compound $Er_3 \square Si_5$. However, this type name is already used for the disordered nonstoichiometric disilicides. Thus, we will refer to this structure type as $Tb_3 \square Si_5$ in accordance with the report by Luo *et al.* (1997).

We did not consider cells based on the Ho₃ \square Si₅ type with doubled *c* parameter, as it is only reported for the $\sqrt{3} \times \sqrt{3}$ type cells.

Further remarks. Gordon et al. (1997) reported a further superstructure for Ce₂PdSi₃ with doubled lattice parameter a and quadrupled c, but did not focus on the specific space group. Therefore, we could not implement this report for the construction of the Bärnighausen diagram. During the literature research we additionally found structures of the EuGe₂type with space group $P\overline{3}1m$ (No. 164). This structure type is very similar to the AlB₂ type, but with a puckered Si sublattice, inducing a translationengleiche transition. Reports about this structure type refer to binary alkaline earth disilicides at nonambient conditions (Evers et al., 1977b; Bordet et al., 2000; Brutti et al., 2006) or with mixed R sites (Eisenmann et al., 1970; Evers et al., 1979) as well as theoretical considerations about the puckering only (Gemming & Seifert, 2003; Gemming et al., 2006; Enyashin & Gemming, 2007; Flores-Livas et al., 2011). As these reports do not meet the requirements of experiments at ambient conditions, we did not consider this group of compounds within this work.

All aforementioned structure types will be termed AlB_2 like in the following sections. By studying the atomic coordinates of the addressed space groups, we observed that the *R* elements form a rigid frame for the structure, as they are mostly the heaviest and largest elements in the structure and, thus, the most immobile. This also means that the Si/T atoms are more mobile and thus puckering of these layers is rather common.

3.1.2. Compounds deduced from ThSi₂ structure type. Compounds of the ThSi₂ type (Brauer & Mittius, 1942) crystallized in space group $I4_1/amd$ (No. 141), see gray box of Fig. 2 (with tetragonal lattice parameters $a_t \approx a_h$, $c_t \approx 13.4-14.4$ Å). The Si/*T* atoms form a complex 3D network, in contrast to the 2D honeycombs in AlB₂. So far, the only reported variation of the ThSi₂ type is the GdSi₂ structure (Perri *et al.*, 1959*b*; Binder, 1960) with independent lattice parameters *a* and *b*. This degree of freedom causes a *translationengleiche* symmetry reduction to space group *Imma* (No. 74).

If the ThSi₂ or GdSi₂ type structures exhibit Si vacancies, these do not order regularly and only cause partially occupied Wyckoff positions. The proportion of vacancies is generally 10% ($RSi_{1.8}$), thus almost one Si ion per tetragonal or orthorhombic unit cell is vacant. The resulting structures remain in the original space group and are called ThSi₂-defect and Nd \Box_xSi_{2-x} , respectively.

In contrast to the distortive modulation of ThSi2, we did not find evidence for a tetragonal superstructure induced by ordering. This absence may be partially due to the small number of reports concerning tetragonal R_2TSi_3 compounds [18 structure reports in ten articles (Gordon et al., 1997; Albering et al., 1994; Kaczorowski & Noël, 1993; Lejay et al., 1983; Chevalier et al., 1986; Li et al., 2008; Mayer & Felner, 1973b; Pöttgen & Kaczorowski, 1993; Raman & Steinfink, 1967; Raman, 1967)]. In order to shed light on a potential ordering, we constructed a tetragonal superstructure based on geometrical, chemical and electronic considerations. First, every Si atom has exactly one T element in its coordination. Second, every T element is coordinated by exactly three Si atoms. Third, every zigzag chain fulfills the 1:3 ratio of T:Si (zigzag chains explained in Section 3.2). And fourth, shortrange periodicity is mandatory; thus, no doubling of the unit cell along the c direction is expected. By choosing an arbitrary atom within the tetragonal Si/T network as the first T element, only two positions unfold positioning the next T element. Two atomic arrangements resulted following the aforementioned conditions. We transferred these patterns onto the simple



Figure 3

Differences in the arrangement of Si/*T* (blue) zigzag chains in hexagonal (left) and tetragonal (right) RSi_2 and R_2TSi_3 compounds. The consecutively added zigzag chains (red bonds) in hexagonal compounds always lie within the same plane, whereas in tetragonal compounds these layers are rotated by 90° along the bonds shown in orange. The 12-fold coordination of the *R* elements is highlighted for one atom ,as an example, with bonds shown in black.

space group P1 (No. 1) and imported them into the tool FINDSYM (Stokes & Hatch, 2005) to determine the space group. Both variants proved to be identical and to exhibit the space group $C222_1$ (No. 20). We will refer to this new structure type with eight instead of four formula units as POTS (proposed ordered, tetragonal structure). The gray box in Fig. 2 visualizes the Si/T-ordering. As this structure has not been reported so far for R_2TSi_3 compounds, we decided to perform DFT calculations to estimate its stability, see Section 3.3.

These three structure types introduced in this section (\$3.1.2) will be addressed as ThSi₂-like in the following.

3.2. Structure description

The hexagonal and the tetragonal subgroups of RSi_2 and R_2TSi_3 compounds do not seem to be symmetrically related at first glance. The AlB₂-like compounds exhibit graphite-like 2D networks of planar Si/*T* hexagons, whereas the Si/*T* atoms of ThSi₂-like compounds form 3D networks. Still, the structures show similarities due to the trigonal coordination of the Si atoms. Fig. 3 illustrates the Si/*T* atoms in trigonal prisms, the 12-fold coordinated *R* atoms (connectors in black) and the Si/*T* zigzag chains (bonds in red/orange) in both structures.

Not only are the hexagonal honeycombs similar to graphite but also the tetragonal 3D network. The typical net exists simultaneously in planes perpendicular to the tetragonal a_t and b_t directions which are interconnected by bonds along the c_t direction. More precisely, two consecutive Si/T zigzag chains are rotated by 90° along the c_t direction, thereby spanning the (100)_t and (010)_t faces of the unit cell and causing incomplete hexagons (see the orange bonds in the ThSi₂ structure type in Fig. 2). This additional symmetry degree of freedom causes a slight deformation of the trigonal Si/T arrangement in the tetragonal network. The Si – T bonds along the c_t direction (in orange, interchain) elongate in comparison to the intrachain bonds (in red), see Fig. 3. Further, the angle within the zigzag chains increases, whereas the other two angles decrease



Figure 4

Overview of the literature reports of RSi_2 and R_2TSi_3 crystals. The number of reports is visualized with numbers and colors (few to very frequent: red – yellow – green – blue – purple). Additionally, to predict the stability for selected unreported structures, this study performed DFT calculations for the highlighted compounds (black circles).

(between bonds shown in red and orange). Therefore, the chains with stronger bonds are slightly flattened compared to the ideal structure with perfect trigonal coordination. These structural differences between hexagonal and tetragonal structure types cause different crystal symmetries that permit a common origin in the Bärnighausen diagram for the RSi_2 and R_2TSi_3 compounds.



Figure 5

Overview of the RSi_2 compounds that were analyzed systematically by the same first author. Some of the results were published in more than one article: Brauer (Brauer & Mittius, 1942; Brauer & Haag, 1950; Brauer & Haag, 1952), Evers (Evers *et al.*, 1977*a*,*b*, 1978*a*,*b*, 1983; Evers, 1979, 1980), Mayer:1 (Mayer *et al.*, 1962, 1967; Mayer & Eshdat, 1968), Perri (Perri *et al.*, 1959*a*,*b*), Pierre (Pierre *et al.*, 1988, 1990).



Figure 6

Overview of the R_2TSi_3 compounds that were analyzed systematically by the same first author according to their *T* element (see color code). Some of the results were published in more than one article: Mayer:2 (Mayer & Tassa, 1969; Mayer & Felner, 1972, 1973*a*,*b*), Szlawska (Szlawska *et al.*, 2007, 2009, 2011, 2016; Szlawska & Kaczorowski, 2011, 2012), Li (Li *et al.*, 1997, 1998,*a*,*b*, 1999, 2001, 2002*a*, 2003, 2008, 2013), Frontzek (Frontzek *et al.*, 2004, 2006; Frontzek, 2009), Mallik (Mallik & Sampathkumaran, 1996; Mallik *et al.*, 1998*a*,*b*,*c*), Xu (Xu *et al.*, 2010, 2011*a*,*b*), Li (Li *et al.*, 1998*b*, 2001, 2002*a*, 2003, 2013).

3.3. Elemental combinations and stability analysis of missing links with DFT calculations

During the literature search, we collected numerous structure reports of various RSi₂ and R₂TSi₃ compounds. Fig. 4 gives an overview of the reported compounds according to their appearance within the R-T grid. In this R-T diagram, we marked the number of reports with different colors, see Fig. 4. This diagram does not include the elements of the Zn group as those compounds were only analyzed at elevated temperatures (Demchenko et al., 2002; Malik et al., 2013; Nasir et al., 2010; Romaka et al., 2012; Salamakha et al., 1998), which are out of the scope of this article. Additionally, we did not find any reports which include R_2 CrSi₃ compounds. We assume that certain electron configurations are necessary for the formation of R_2TSi_3 compounds. Furthermore, some elements rarely appear within the R_2 Si and R_2T Si₃ compounds, such as Sm and Yb, which are highly volatile (Cao, 2014, private communication), Tc, which has a very low radio-active halflife and is very scarce (Holleman & Wiberg, 2007), or Pm, which is radioactive (Cao, 2014, private communication; Frontzek, 2014, private communication). The interest in using La and Lu was lower as most of the research aimed for the magnetic properties that do not exist for these two elements (Frontzek, 2014, private communication). The cost of the elements seems to play a subordinate role, e.g. the more expensive Rh (89 000 USD per kg) compounds were analyzed more frequently than the ones containing Ir (36 000 USD per kg) (Havnes, 2012).

These distributions are emphasized in Figs. 5, 6 and 7, which show systematic approaches in the literature. Fig. 5 gives an





Overview of the R_2TSi_3 compounds that were analyzed systematically by the same first author according to their *R* element (see color code). Some of the results were published in more than one article: Mayer:2 (Mayer & Tassa, 1969; Mayer & Felner, 1972, 1973*a*,*b*), Szlawska (Szlawska *et al.*, 2007, 2009, 2011, 2016; Szlawska & Kaczorowski, 2011, 2012), Li (Li *et al.*, 1997, 1998*a*,*b*, 1999, 2001, 2002*a*, 2003, 2008, 2013), Frontzek (Frontzek *et al.*, 2004, 2006; Frontzek, 2009), Pottgen (Pöttgen & Kaczorowski, 1993; Pöttgen *et al.*, 1994), Majumdar (Majumdar *et al.*, 1998, 1999*a*,*b*, 2000, 2001).

overview of RSi_2 series with the corresponding authors and R elements. This summary shows the high interest in the lanthanide compounds compared to R elements of the alkaline earth metals and the actinides. Fig. 6 shows a similar illustration of T series within the R_2TSi_3 compounds. Sorted by T element and author, the corresponding R elements are highlighted. Within the 3d elements the largest variety was analyzed, mostly in combination with La and Ce. In contrast, the heavy lanthanides were more favored when 4d elements were used, which have been intensively studied. Finally, Fig. 7 shows the R series, sorted by R element and author, with highlighted T elements. Again, the focus on the 3d elements as well as La and Ce is clear. The most complete investigations were carried out for U and Th, which emphasizes their importance for reactor technology.

By studying the R-T diagram of Fig. 4 one main question arises: What are the stability relationships of those R_2TSi_3 compounds that are missing? To clarify this question, we sorted the compounds according their R element and discuss the Co, Rh and Pt series in the following sections.

We assumed ordered structures as DFT cannot evaluate mixed positions, except in the framework of virtual crystal approximations (VCA) using potential mixing. We adapted the structure type of the adjacent compounds within the R-Tgrid or used the highly symmetric Ce₂CoSi₃ structure type with space group *P6/mmm* (No. 191) as the basis for the unknown compounds. Table 17 summarizes the formation energies and lattice parameters all considered compounds. We will compare the formation energy of an unreported compound with those of similar reported compounds to evaluate its relative stability.

The DFT results of all models indicate metallic structures, although the DFT band gap problem may suppress the appearance of small band gaps. Thus, all structures have an intrinsic buffer of electronic states at the Fermi level to account for stability considerations of the T coordination within the ionic Si/T subnetwork according to molecular orbital theory, see Nentwich *et al.* (2020).

The first compound of interest is Nd₂CoSi₃. The series of Nd compounds is fairly complete, compare Fig. 4, for example,



Figure 8 Formation energies of some R_2TSi_3 compounds in different structure types.

with reported Nd₂RhSi₃ (Chevalier et al., 1983, 1984; Szytuła et al., 1993; Mitsufuji et al., 1996; Gribanov et al., 2010; Zajdel et al., 2015), which is the 4d analog compound to Nd₂CoSi₃. Additionally, we found comments on this compound in two publications, but without any information concerning property, structure and phase purity (Chevalier et al., 1984; Szytuła et al., 1993). The formation energies and existing structure types of La₂CoSi₃ and Ce₂CoSi₃ serve as references. Furthermore, the likewise hypothetical compound Pr₂CoSi₃ was also calculated. The blue markers in Fig. 8 show the respective formation energies ranging from -4.61 eV to -4.37 eV. The lowest energy results for R = Ce and the highest for R = Nd. As the formation energy of Pr₂CoSi₃ lies in between the reported compounds, we expect it to be stable. The energy difference between Nd₂CoSi₃ and La₂CoSi₃ (the reported compound with highest energy) is 25 meV per atom. This corresponds to the tolerance limit; thus, we conclude that Nd₂CoSi₃ could also be stable. This conclusion is supported by the reports of Mayer & Tassa (1969) and Felner & Schieber (1973) on Pr₂Co_{0.8}Si_{3.2} and $Nd_2Co_{0.8}Si_{3.2}$. They also synthesized samples with higher T content, which lead to 'the disappearance of the AlB₂ type phase, and the X-ray patterns obtained could not be interpreted' (Mayer & Tassa, 1969). Nevertheless, we think that the synthesis of Pr₂CoSi₃ and Nd₂CoSi₃ and the interpretation of the corresponding X-ray patterns would be successful nowadays due to improved hardware and measurement techniques. Additionally, an enhanced thermal treatment would certainly improve the crystal quality regarding the Si/T ordering. Thus, we advise reinvestigating the R_2TSi_3 compounds discussed by Mayer & Tassa (1969), with R = La, Ce, Pr, Nd, Sm, Gd and T = Fe, Co, Ni.

Another interesting compound is Eu₂RhSi₃. The Rh series is well represented in the R-T diagram and its 3d analog Eu_2CoSi exists. However, the *R* element Eu supposedly only forms a compound with Co, but not with Rh (Mayer & Tassa, 1969; Mayer & Felner, 1973a). We also modeled R_2 RhSi₃ compounds with R elements Gd, Tb, Dy and Ho again and used the formation energies of existing structures as references. For the Rh series, the formation energies range from -6.68 eV to -4.34 eV, with the not yet reported Eu₂RhSi₃ having the highest formation energy. Both tested symmetries the higher symmetric Ce₂CoSi₃ and the lower symmetric Er₂RhSi₃ – gave almost the same results, for formation energies (-4.34 eV) and interatomic distances $[d_a(R,R) \approx 4.13 \text{ \AA}]$ $d_c(R,R) \approx 4.27$ Å]. The formation energy of Eu₂RhSi₃ differs from the second highest formation energy of Ho₂RhSi₃ by 160 meV per atom which exceeds the limit of 25 meV per atom, see green markers in Fig. 8. Therefore, the Eu₂RhSi₃ compound in Ce₂CoSi₃ or Er₂RhSi₃ structure type is significantly less stable.

The third compound of interest is Eu_2PtSi_3 . In the R_2PtSi_3 series only a few element combinations have not yet been experimentally confirmed. Nevertheless, we identified missing compounds for *R* between Nd and Gd. Due to the radioactivity and low abundance of Pm and the volatility of Sm, we chose the Eu compound for further investigation. In analogy to the Rh series, we additionally chose R = Gd, Tb, Dy as references for formation energy and structure. In addition we modeled the not-yet-reported compound Ho₂PtSi₃. We decided to calculate the compounds in the reported Er₂RhSi₃ $(P\overline{6}2c)$ symmetry and additionally in the higher symmetric type Ce₂CoSi₃ as well as in the lowest possible symmetry P1 (No. 1) to evaluate the influence of the degrees of freedom onto the formation energies. The energies for the R_2 PtSi₃ compounds range from -6.18 eV to -5.11 eV, see orange markers in Fig. 8. Except for Eu, the energies of different compounds and also different structure types are very similar. As expected, the energies of the lower symmetric Er₂RhSi₃ structure types are always lower than those of the highly symmetric type Ce₂CoSi₃, due to the additional degrees of freedom in atomic positions. The spread is between 0 meV for Gd and 28 meV for Ho per atom and about additional 1 meV going down to P1 (No. 1). The energies of the low-symmetric versions of the R_2 PtSi₃ compounds are even lower than that of existing Gd₂PtSi₃. The formation energy of the (still) hypothetical Ho₂PtSi₃ in Ce₂CoSi₃ type structure is 33 meV per atom higher than that of Gd₂PtSi₃, thus this high-symmetry type is certainly not stable. However, the lower symmetry types will very probably be stable. The formation energy of Eu₂PtSi₃ is 14 meV per atom higher than for Gd₂PtSi₃; therefore, the compound is in the two considered symmetries most probably accessible as the thermodynamically stable phase. On the one hand, these data show that in some cases $(Eu_2RhSi_3, Eu_2PtSi_3 \text{ and } Gd_2PtSi_3)$ the formation energy hardly changes for different structure types. On the other hand, the formation energy of different structure types may change so strongly that our relative limit of 25 meV per atom is by far exceeded and only the lower symmetric variations may be stable. This is the case for Tb₂PtSi₃, Dy₂PtSi₃ and Ho₂PtSi₃.

After analyzing those three *R* series, we discovered further characteristics in the R-T diagram worth studying for different reasons. Compound La₂PdSi₃ attracted our attention because Chaika et al. (2001) and Behr et al. (2008) have already successfully synthesized this compound, but did not determine the lattice parameters or structural information during their investigations. We performed DFT calculations for La₂PdSi₃ using the Ce₂CoSi₃ structure type as well. The formation energy is lower than for the chemically similar compound La₂CoSi₃ which was reported in the ordered structure type Ce_2CoSi_3 . Thus, we conclude that the Ce_2CoSi_3 type may be a stable configuration for La2PdSi3, next to the disordered AlB2 type. The relaxed parameters a = 8.34 Å and c = 4.38 Å are very close to the lengths expected from the adjacent compounds La₂RhSi₃ and Ce₂PdSi₃ ($a \approx 8.25$ Å, $c \approx 4.3$ Å). We recommend checking La2PdSi3 for indicators of an ordered Si/T site, e.g. satellite reflections.

Furthermore, we wondered which structure would arise for stoichiometric BaSi₂. Most reported space groups of BaSi₂ are orthorhombic (Imai & Watanabe, 2010; Evers, 1980; Janzon *et al.*, 1970; Kitano *et al.*, 2001; Migas *et al.*, 2007; Schäfer *et al.*, 1963; Evers *et al.*, 1977b, 1978a) and do not fit into our Bärnighausen diagram and are, therefore, not listed in Table 1 nor depicted in Figs. 4 and 9. The only exception is a hexagonal

phase determined by Gladyshevskii (1959). In fact, the original sample had Li impurities and exhibits the structure type Ba₄Li₂Si₆, discovered by von Schnering et al. (1996). This finding explains the discrepancy with the tetragonal phases of the related alkaline earth compounds CaSi2 and SrSi2, e.g. Evers et al. (1977a,b). We tested both an hexagonal and a tetragonal variant for BaSi₂ to evaluate which symmetry is more stable. Additionally, we modeled SrSi₂ in both the hypothetical AlB₂ and the already reported ThSi₂ structure type to compare the formation energies. As expected, the formation energy of tetragonal SrSi₂ is lower than the one of hexagonal SrSi₂. The energies for both BaSi₂ models are almost identical (-2.06 eV) and, thus, expected to be equally stable. Nevertheless, these data alone are not sufficient to convey the stability of BaSi2 to SrSi2 as the elements Ba and Sr are too different. Furthermore, given the degrees of freedom, the tetragonal model of BaSi₂ relaxed into an orthorhombic lattice with differences in lattice parameters a and b in the order of 0.4%. It should be noted that the *a* parameters of hexagonal and tetragonal symmetry differ for both BaSi2 and SrSi₂ compounds (see Table 18), although they are alike for dimorphic compounds of the family, e.g. GdSi₂.

Subsequently, we use the chemical similarity of Ba and Sr to evaluate which orthorhombic structure type is more favorable for compound Sr_2AgSi_3 , as it is the only alkaline earth compound that has not yet been synthesized. Both, the $Ba_4Li_2Si_6$ type of $(Ba_2Eu)_2AgSi_3$ and the Ca_2AgSi_3 type are reasonable. We excluded other structure types as other chemically similar compounds only crystallize in those two structures. Here, chemically similar means a noble metal *T* and *R* preferring the +II oxidation state (*e.g.* alkaline earth metals, Eu and Yb). For *T* = Ag, Sr_2AgSi_3 is the only alkaline earth compound that has not yet been synthesized.

As a reference, we used Ba_2AgSi_3 , also in both structure types. For Ba_2AgSi_3 , the respective formation energies exhibited a clear preference for the reported Ca_2AgSi_3 type



Figure 9

R-T diagram of the RSi_2 and R_2TSi_3 compounds. The color of the markers symbolizes the range of ordering *n*, see Section 3.4. If the structure is disordered (AlB₂, ThSi₂, GdSi₂), then n = 0 and the symbol is gray. If the structure is ordered, the range of ordering accords to the number of stacks along *c* in the unit cell. Up to three markers on one grid position are possible, representing different publications.

structure. However, the formation energies for both Sr_2AgSi_3 models are almost identical with a value of -2.83 eV, therefore we conclude that both structure types are equally stable. The formation energy of Sr_2AgSi_3 is slightly lower than that of Ba_2AgSi_3 , which supports a stable structure.

Finally, we consider the potential tetragonal R_2TSi_3 superstructure as determined in Section 3.1. We did not find reports on this ordered tetragonal structure and expect that it is energetically unfavored. Only a few articles on suitable compounds exist, mainly containing Th compounds (Albering et al., 1994; Lejay et al., 1983; Chevalier et al., 1986; Li et al., 2008; Raman, 1967; Kaczorowski & Noël, 1993; Pöttgen & Kaczorowski, 1993) as well as U₂CuSi₃ (Albering et al., 1994; Lejay et al., 1983; Chevalier et al., 1986), La2AlSi3 (Raman & Steinfink, 1967), Ce₂AuSi₃ (Gordon et al., 1997), Er₂CuSi₃ and Nd₂AgSi₃. We chose Nd₂AgSi₃ for better comparability, as several compounds with either Nd or Ag have already been examined in the previous discussions. To compare our hypothetical tetragonal superstructure with an existing structure, we chose the hexagonal Ce₂CoSi₃ type, since the most obvious tetragonal ThSi₂ type exhibits mixed positions. We further took the disilicide NdSi2 into account in both ThSi2 and AlB2 type structures.

Please note that the lattice parameters of the POTS type (calculated) are related to those of the ThSi₂ type (experimental) by rotation and elongation by a factor of $\approx \sqrt{2}$. Thus, the interatomic distances of both tetragonal structure types of Nd₂AgSi₃ are approximately the same $a_{\text{ThSi2}} = 4.12$ Å ≈ 4.21 Å $= a_{\text{POTS}}/\sqrt{2}$. For Nd₂CuSi₃, we compared three different symmetries, the high symmetry Ce₂CoSi₃, experimentally confirmed Er₂RhSi₃ (*P*62*c*) and low symmetry *P*1 (No. 1). The lattice parameters of all three models are a = 8.06 Å and $c \approx 4.24$ Å, which is in good agreement with the experimental values [Er₂RhSi₃ (*P*62*c*)-type].

The formation energies of Nd₂AgSi₃ stoichiometry are -3.69 eV for the Ce₂CoSi₃ type and -3.72 eV for the tetragonal superstructure. With an absolute formation energy which is lower by 0.30 eV per atom, the tetragonal type is clearly favored. In general, the superstructural order for tetragonal symmetries may be suppressed for further reasons. On the one hand, the 3D Si/T network itself may present kinetic barriers. On the other hand, the entropy of mixing may hinder structural ordering more severe for the degeneracies of the 3D Si/T network than for the planar stacking of hexagonal symmetries.

3.4. Structure distribution

Fig. 9 gives an overview of the scatter of structure types within the RSi_2 and R_2TSi_3 compounds. This figure adapts the R-T grid of Fig. 4 with symbols announcing symmetry and range of order. To quantify the ordering within the different structure types, we defined the range of order as zero if the Si/T atoms do not order and otherwise as the number of Si/T layers along c in the unit cell. The range of order is highlighted by the color of the marker. The symmetry is marked by shape:

hexagon for hexagonal AlB₂-like, open star for orthorhombic AlB₂-like, diamond for tetragonal ThSi₂, elongated diamond for orthorhombic GdSi₂. For technical reasons, this diagram shows at most three reports of the same compound (left, right, bottom). Our algorithm chooses the datasets with the highest as well as the lowest *a* parameter and an additional dataset with a different structure type, to depict the most significant variations. Fig. 9 visualizes the range of order in dependence on the atomic number of the *R* and *T* cations; it depicts the following trends:

First, most of the compounds in the grid exhibit an hexagonal AlB₂-like lattice. The other lattice types are mainly determined by the included R and T element. For example, the orthorhombic GdSi₂ structure type arises exclusively for lanthanide disilicides. The tetragonal lattice is dominant for R= Th compounds as well as for the disilicides with light rare earth elements. Additional compounds with tetragonal lattice are Ce₂AuSi₃, Nd₂AgSi₃ and Er₂CuSi₃, all possessing a noble metal T element. Thus, the Fermi level of the T element affects the structural stability, see Nentwich *et al.* (2020).

Furthermore, the completely ordered orthorhombic structure types Ca_2AgSi_3 and $Ba_4Li_2Si_6$ are only reported for R_2TSi_3 compounds with the monovalent ions T = Ag, Au and the divalent ions R = Ca, Ba, Eu, Yb (Cardoso Gil *et al.*, 1999; Sarkar *et al.*, 2013). The partially ordered structure type U_2RhSi_3 additionally arises for U_2PdSi_3 (Chevalier *et al.*, 1996). Here, we do not consider the compound Ba_2LiSi_3 itself, since Li does not accord with our limitations to the *T* elements. Thus, the ordered orthorhombic AlB₂-like structure types are more probable if the *T* element is a monovalent atom and if the *R* element prefers the +II oxidation state – as for the alkaline earth metals.

Second, tetragonal LaSi₂ does not follow the hexagonal symmetry of the disilicides with third group elements Sc and Y. This phenomenon illustrates the affiliation of Sc and Y to the heavy and of La to the light rare earth elements (RÖMPP Online, 2011).

Third, with increasing atomic number of R within the lanthanide disilicides, three structure types succeed each other. The tetragonal ThSi₂ type is the dominant one for light rare earth elements (Ce-Eu), followed by the orthorhombic GdSi₂ type in the intermediate range and the hexagonal AlB₂ type for the heavy rare earth elements (according to the classification by Sitzmann; RÖMPP Online, 2011). This development is present in all samples independent of their thermal treatment, see Nentwich et al. (2020). This meets an observation of Mayer et al. (1967): upon heating the samples to 1600°C, they discovered two phase transformations, one from AlB_2 type to $GdSi_2$ type and another one from $GdSi_2$ type to ThSi₂ type. These transformations are reversible. A decreasing atomic number within the lanthanide group is accompanied with a significantly increasing radius and therefore with a higher space requirement. Increased thermal lattice vibrations at higher temperatures also cause higher space requirements. Thus, annealing has the same effect as decreasing the atomic number of R.

4. Conclusions

We present an extensive literature study of the RSi_2 and R_2TSi_3 compounds crystallizing in AlB₂- and ThSi₂-like structures complemented by DFT calculations. The local similarities between these structures, *e.g.* threefold planar coordination of the Si/T atoms, twelvefold coordination of the R elements, are highlighted and discussed. Additionally, we systematized the structure data and arranged them in a Bärnighausen diagram showing the relationships between structure types. We were able to determine the space groups of the ordered nonstoichiometric disilicides as piezoelectric $P\overline{6}2m$ (No. 189), $P\overline{6}2c$ (No. 190) and P2mm (No. 25).

According to Bodak & Gladyshevskii (1985), compounds La_2FeSi_3 , La_2CoSi_3 , La_2NiSi_3 , Ce_2CuSi_3 and Ce_2NiSi_3 form a solid solution of structure type AlB₂ (disordered Si/*T* sites). Nevertheless, as evident from the discussion, we conclude that superstructures are expected to be the thermodynamic equilibrium structures, although they may be hard to synthesize, as they require obtaining the exact chemical composition on the one hand and for a careful thermal treatment on the other hand.

Comparison of the symmetry distribution within the R-T grid showed a special characteristic of the structure types Ca_2AgSi_3 and $Ba_4Li_2Si_6$. These structure types only arise if R has the formal +II oxidation state and T is either Au or Ag. Additionally, these structures are reported to have ionic character, whereas all other compounds are reported to be metallic. The given R-T diagram also shows a transition from tetragonal ThSi₂ to orthorhombic GdSi₂ to hexagonal AlB₂ type within the lanthanide disilicides with increasing atomic number of R. The structure types behave similarly with increasing temperature when respective crystals are heated.

Figs. 5 to 7 emphasize the number of systematic investigations of the RSi_2 and R_2TSi_3 compounds. On the one hand, these systematic investigations reduce systematic errors. On the other hand, the author's expectations may also have an impact on the evaluation (such as the structure type).

Concluding the DFT analysis, hypothetical compounds Ho₂PtSi₃, Pr₂CoSi₃, Eu₂PtSi₃ and Nd₂CoSi₃ are suggested to be stable, whereas Eu₂RhSi₃ will be unstable. Due to the positive results for Pr₂CoSi₃ and Nd₂CoSi₃, we recommend reinvestigating the R_2TSi_3 compounds reported by Maver & Tassa (1969), with R = La, Ce, Pr, Nd, Sm, Gd and T = Fe, Co, Ni (originally with $R_2T_{0.8}$ Si_{3.2} stoichiometry). To complete the crystal structure information of La₂PdSi₃, we predict the lattice parameters a = 8.34 Å and c = 4.38 Å in a Ce₂CoSi₃ type structure. With respect to the question whether Sr_2AgSi_3 prefers the Ca₂AgSi₃ or the Ba₄Li₂Si₆ structure type, both models result in almost identical formation energies of -2.83 eV and are equally stable from a theoretical point of view. Likewise, BaSi₂ may exhibit hexagonal as well as tetragonal symmetry, as the formation energy of both models is -1.03 eV. In comparison, the potential tetragonal superstructure is less favorable than a highly symmetric hexagonal

structure. The results of this work do not exclude the existence of structures that are equally or more stable than the ones presented here. The solid solutions with disorder at the Si/T position may always present potential candidates for the ground state of a specific R_2T Si₃ compound.

At this point, the question of particular driving forces for a certain type of symmetry and the multiplicity of the superstructure symmetry types and structure types remains. This question will be addressed in the second part of this work (Nentwich *et al.*, 2020) focusing on the electronic structure.

APPENDIX A

Wyckoff positions of the different superstructures

Wyckoff positions of the different superstructures are presented here in Tables 2, 3, 4, 5, 6, 7, 8, 9, 10, 11, 12, 13, 14, 15, 16 and 17.

Table 2

Wyckoff positions of the hexagonal aristotypic structure type AlB₂ with space group *P6/mmm* (No. 191) and lattice parameters $a_{\rm h} \approx 3.00$, $c_{\rm h} \approx 3.24$ Å.

| Element | Wyckoff symbol | x | у | z |
|---------|----------------|---------------|---------------|---------------|
| R | 1 <i>a</i> | 0 | 0 | 0 |
| Si/T | 2d | $\frac{1}{3}$ | $\frac{1}{3}$ | $\frac{1}{2}$ |

Table 3

Wyckoff positions of the hexagonal structure type Ce₂CoSi₃ with space group *P6/mmm* (No. 191) and lattice parameters $a \approx 2a_{\rm h}, c \approx c_{\rm h}$.

| Element | Wyckoff symbol | x | у | z |
|---------|----------------|---------------------------------------|--|---------------|
| R | 1 <i>a</i> | 0 | 0 | 0 |
| R | 3 <i>f</i> | $\frac{1}{2}$ | 0 | 0 |
| Т | 2d | 1 3 | $\frac{2}{3}$ | $\frac{1}{2}$ |
| Si | 6 <i>m</i> | $x_{\mathrm{Si}} \approx \frac{1}{6}$ | $2x_{\mathrm{Si}} \approx \frac{2}{6}$ | $\frac{1}{2}$ |

Table 4

Wyckoff positions of the hexagonal structure type U₂RuSi₃ with space group *P6/mmm* (No. 191) and lattice parameters $a \approx 2a_{\rm h}$, $c \approx c_{\rm h}$.

The Si site is only half occupied.

| Element | Wyckoff symbol | x | у | z |
|---------|----------------|----------------------------------|-----------------------------------|----------------------------------|
| R | 1 <i>a</i> | 0 | 0 | 0 |
| R | 3f | $\frac{1}{2}$ | 0 | 0 |
| Т | 2d | 1 3 | $\frac{2}{3}$ | $\frac{1}{2}$ |
| Si | 120 | $x_{\rm Si} \approx \frac{1}{6}$ | $2x_{\rm Si} \approx \frac{2}{6}$ | $z_{\rm Si} \approx \frac{1}{2}$ |

| Table 5 |
|--|
| Wyckoff positions of the hexagonal structure type Er ₂ RhSi ₃ with space |
| group $P6_3/mmc$ (No. 194) and lattice parameters $a \approx 2a_{\rm h}, c \approx 2c_{\rm h}$. |

| Element | Wyckoff symbol | x | у | z |
|---------|----------------|----------------------------------|-----------------------------------|------------------------|
| R | 2b | 0 | 0 | $\frac{1}{4}$ |
| R | 6 <i>h</i> | $x_R \approx \frac{1}{2}$ | $2x_R \approx 0$ | $\frac{1}{4}$ |
| Т | 4f | 1 3 | $\frac{2}{3}$ | $z_T \approx 0$ |
| Si | 12 <i>k</i> | $x_{\rm Si} \approx \frac{1}{6}$ | $2x_{\rm Si} \approx \frac{1}{3}$ | $z_{\rm Si} \approx 0$ |

Table 6

Wyckoff positions of the hexagonal structure type Er_2RhSi_3 with space group $P\overline{6}2c$ (No. 190) and lattice parameters $a \approx 2a_{\text{h}}, c \approx 2c_{\text{h}}$.

| Element | Wyckoff symbol | x | у | z |
|---------|----------------|----------------------------------|----------------------------------|------------------------|
| R | 2 <i>b</i> | 0 | 0 | $\frac{1}{4}$ |
| R | 6 <i>h</i> | $x_R \approx \frac{1}{2}$ | $y_R \approx \frac{1}{2}$ | 1 |
| Т | 4f | 1 3 | $\frac{2}{3}$ | $z_T \approx 0$ |
| Si | 12 <i>h</i> | $x_{\rm Si} \approx \frac{1}{6}$ | $y_{\rm Si} \approx \frac{1}{3}$ | $z_{\rm Si} \approx 0$ |

Table 7 Wyckoff positions of the orthorhombic structure type Ho₂PdSi₃ with space group I112/b (No. 15) and lattice parameters $a \approx 2a_{\rm h}$, $c \approx 8c_{\rm h}$.

| Element | Wyckoff symbol | x | у | z |
|---------|----------------|---|--|--------------------------------------|
| R | 4 <i>e</i> | 0 | $\frac{1}{4}$ | $z_{R,1} \approx 0$ |
| R | 4e | 0 | 1 4 | $z_{R,2} \approx \frac{1}{8}$ |
| R | 4e | 0 | $\frac{1}{4}$ | $z_{R,3} \approx \frac{2}{8}$ |
| R | 4e | 0 | $\frac{1}{4}$ | $z_{R,4} \approx \frac{3}{8}$ |
| R | 4e | 0 | $\frac{1}{4}$ | $z_{R,5} \approx \frac{4}{8}$ |
| R | 4e | 0 | 1 4 | $z_{R,6} \approx \frac{5}{8}$ |
| R | 4 <i>e</i> | 0 | $\frac{1}{4}$ | $z_{R,7} \approx \frac{6}{8}$ |
| R | 4e | 0 | $\frac{1}{4}$ | $z_{R,8} \approx \frac{7}{8}$ |
| Т | 8 <i>f</i> | $x_{T,1} \approx \frac{1}{6}$ | $y_{T,1} \approx \frac{1}{12}$ | $z_{T,1} \approx \frac{7}{16}$ |
| Т | 8 <i>f</i> | $x_{T,2} \approx \frac{1}{6}$ | $y_{T,2} \approx \frac{1}{12}$ | $z_{T,2} \approx \frac{13}{16}$ |
| Si | 8 <i>f</i> | $x_{\mathrm{Si},1} \approx \frac{1}{6}$ | $y_{\rm Si,1} \approx \frac{1}{12}$ | $z_{Si,1} \approx \frac{1}{16}$ |
| Si | 8 <i>f</i> | $x_{\mathrm{Si},2} \approx \frac{1}{6}$ | $y_{\rm Si,2} \approx \frac{1}{12}$ | $z_{Si,2} \approx \frac{3}{16}$ |
| Si | 8 <i>f</i> | $x_{\mathrm{Si},3} \approx \frac{1}{6}$ | $y_{\mathrm{Si},3} \approx \frac{1}{12}$ | $z_{Si,3} \approx \frac{5}{16}$ |
| Si | 8 <i>f</i> | $x_{\mathrm{Si},4} \approx \frac{1}{6}$ | $y_{\mathrm{Si},4} \approx \frac{1}{12}$ | $z_{Si,4} \approx \frac{9}{16}$ |
| Si | 8 <i>f</i> | $x_{\rm Si,5} \approx \frac{1}{6}$ | $y_{\rm Si,5} \approx \frac{1}{12}$ | $z_{\rm Si,5} \approx \frac{11}{16}$ |
| Si | 8 <i>f</i> | $x_{\mathrm{Si},6} \approx \frac{1}{6}$ | $y_{\rm Si,6} \approx \frac{1}{12}$ | $z_{Si,6} \approx \frac{15}{16}$ |

 Table 8

 Wyckoff positions of the orthogenetic

Wyckoff positions of the orthorhombic structure type $\text{Er}_3 \square \text{Si}_5$ with space group *Pmmm* (No. 47) and lattice parameters $a \approx a_h, b \approx \sqrt{3}a_h, c \approx c_h$.

| Element | Wyckoff symbol | x | у | z |
|---------|----------------|---------------|---|---------------|
| R | 1 <i>a</i> | 0 | 0 | 0 |
| R | 1f | $\frac{1}{2}$ | $\frac{1}{2}$ | 0 |
| Si/T | 2p | 1/2 | $y_{\mathrm{Si}/T,1} \approx \frac{1}{4}$ | $\frac{1}{2}$ |
| Si/T | 2 <i>n</i> | 0 | $y_{\mathrm{Si}/T,2} \approx \frac{1}{4}$ | $\frac{1}{2}$ |

Table 9

Wyckoff positions of the orthorhombic structure type U₂RhSi₃ with space group *Pmmm* (No. 47) and lattice parameters $a \approx a_h, b \approx \sqrt{3}a_h, c \approx c_h$.

| Element | Wyckoff symbol | x | у | z |
|---------|----------------|---------------|----------------------------------|---------------|
| R | 1 <i>a</i> | 0 | 0 | 0 |
| R | 1f | $\frac{1}{2}$ | $\frac{1}{2}$ | 0 |
| Si/T | 2 <i>n</i> | 0 | $y_T \approx \frac{1}{3}$ | $\frac{1}{2}$ |
| Si | 2p | $\frac{1}{2}$ | $y_{\rm Si} \approx \frac{5}{6}$ | 1/2 |

Table 10

Wyckoff positions of the orthorhombic structure type Ca₂AgSi₃ with space group *Fmmm* (No. 69) and lattice parameters $a \approx 2a_{\rm h}$, $b \approx 2c_{\rm h}$, $c \approx 2\sqrt{3}a_{\rm h}$.

| Element | Wyckoff symbol | x | у | z |
|---------|----------------|---|--|---------------------------|
| R | 8 <i>i</i> | 0 | 0 | $z_R \approx \frac{1}{4}$ |
| R | 8 <i>f</i> | $\frac{1}{4}$ | $\frac{1}{4}$ | 1 4 |
| Т | 8h | 0 | $y_T \approx \frac{2}{3}$ | 0 |
| Si | 8 <i>h</i> | 0 | $y_{\rm Si,1} \approx \frac{1}{6}$ | 0 |
| Si | 160 | $x_{\mathrm{Si},2} \approx \frac{1}{4}$ | $y_{\mathrm{Si},2} \approx \frac{1}{12}$ | 0 |

Table 11

Wyckoff positions of the orthorhombic structure type Ho₃ \square Si₅ with space group *P2mm* (No. 25) and lattice parameters $a \approx 3a_{\rm h}, b \approx \sqrt{3}a_{\rm h}, c \approx 2c_{\rm h}$.

| Element | Wyckoff symbol | x | у | z |
|---------|----------------|---|-------------------------------------|---------------|
| R | 1 <i>a</i> | 0 | $y_{R,1} \approx 0$ | 0 |
| R | 1b | $\frac{3}{6}$ | $y_{R,2} \approx \frac{1}{2}$ | 0 |
| R | 2g | $x_{R,1} \approx \frac{2}{6}$ | $y_{R,3} \approx 0$ | 0 |
| R | 2g | $x_{R,2} \approx \frac{1}{6}$ | $y_{R,4} \approx \frac{1}{2}$ | 0 |
| | 1 <i>c</i> | 0 | $y_{\square,1} \approx \frac{2}{6}$ | $\frac{1}{2}$ |
| | 1d | 3 6 | $y_{\square,1} \approx \frac{5}{6}$ | $\frac{1}{2}$ |
| Si | 1 <i>c</i> | 0 | $y_{\rm Si,1} \approx \frac{4}{6}$ | $\frac{1}{2}$ |
| Si | 1d | $\frac{3}{6}$ | $y_{\rm Si,2} \approx \frac{5}{6}$ | 1 2 |
| Si | 2h | $x_{\mathrm{Si},1} \approx \frac{2}{6}$ | $y_{\rm Si,3} \approx \frac{4}{6}$ | $\frac{1}{2}$ |
| Si | 2h | $x_{\mathrm{Si},2} \approx \frac{1}{6}$ | $y_{\rm Si,4} \approx \frac{5}{6}$ | $\frac{1}{2}$ |
| Si | 2h | $x_{\mathrm{Si},3} \approx \frac{1}{6}$ | $y_{\rm Si,5} \approx \frac{1}{6}$ | 1 2 |
| Si | 2h | $x_{\mathrm{Si},4} \approx \frac{2}{6}$ | $y_{\rm Si,6} \approx \frac{2}{6}$ | 1 2 |

Table 12

Wyckoff positions of the orthorhombic structure type Ba₄Li₂Si₆ with space group *Fddd* (No. 70) and lattice parameters $a \approx 2a_{\rm h}$, $b \approx 2\sqrt{3}a_{\rm h}$, $c \approx 4c_{\rm h}$.

| Element | Wyckoff symbol | x | у | z |
|---------|----------------|---|---|---|
| R | 16g | $\frac{1}{8}$ | $\frac{1}{8}$ | $z_{R,1} \approx \frac{2}{8}$ |
| R | 16 <i>g</i> | 1/8 | 1/8 | $z_{R,2} \approx \frac{6}{8}$ |
| Т | 16 <i>f</i> | 1/8 | $y_T \approx \frac{7}{24}$ | 18 |
| Si | 16 <i>f</i> | 1/8 | $y_{\mathrm{Si},1} \approx \frac{11}{24}$ | 1 8 |
| Si | 32h | $x_{\mathrm{Si},2} \approx \frac{1}{8}$ | $y_{\mathrm{Si},2} \approx \frac{7}{24}$ | $z_{\mathrm{Si},2} \approx \frac{1}{8}$ |

Table 13 Wyckoff positions of the Si vacancy cell of structure type Yb₃ \square Si₅ with space group $P\overline{6}2m$ (No. 189) and lattice parameters $a \approx \sqrt{3}a_{\rm h}$, $c \approx c_{\rm h}$.

| Element | Wyckoff symbol | x | у | z |
|---------|----------------|----------------------------------|---------------|---------------|
| R | 3 <i>f</i> | $x_R \approx \frac{2}{3}$ | 0 | 0 |
| | 1b | 0 | 0 | $\frac{1}{2}$ |
| Si | 3g | $x_{\rm Si} \approx \frac{1}{3}$ | 0 | $\frac{1}{2}$ |
| Si | 2d | $\frac{1}{3}$ | $\frac{2}{3}$ | 1 2 |

Table 14

Wyckoff positions of the Si vacancy cell of structure type Tb₃ \Box Si₅ with space group $P\overline{6}2c$ (No. 190) and lattice parameters $a \approx \sqrt{3}a_{\rm h}, c \approx 2c_{\rm h}$.

| Element | Wyckoff symbol | x | у | z |
|---------|----------------|----------------------------------|----------------------------------|---------------|
| R | 6g | $x_R \approx \frac{1}{3}$ | 0 | 0 |
| | 2c | 0 | 0 | $\frac{1}{4}$ |
| Si | 6 <i>h</i> | $x_{\rm Si} \approx \frac{1}{3}$ | $y_{\rm Si} \approx \frac{1}{3}$ | $\frac{1}{4}$ |
| Si | 2d | 23 | 13 | $\frac{1}{4}$ |
| Si | 2b | 0 | 0 | $\frac{1}{4}$ |

Table 15

Wyckoff positions of the tetragonal structure type ThSi₂ with space group $I4_1/amd$ (No. 141) with lattice parameters $a_t \approx a_h$, $c_t \approx 13.4-14.4$ Å.

| Element | Wyckoff symbol | x | у | z |
|---------|----------------|---|---|---|
| R | 4a | 0 | 0 | $\frac{1}{8}$ |
| Si/T | 8 <i>e</i> | 0 | 0 | $z_{\mathrm{Si}/T} \approx \frac{7}{2^4}$ |

Table 16

Wyckoff positions of the orthorhombic structure type $GdSi_2$ with space group *Imma* (No. 74) and lattice parameters $a \approx a_t$, $c \approx c_t$.

| Element | Wyckoff symbol | x | у | z |
|---------|----------------|---|---------------|--|
| R | 4 <i>e</i> | 0 | $\frac{1}{4}$ | $z_R \approx \frac{1}{8}$ |
| Si/T | 4 <i>e</i> | 0 | $\frac{1}{4}$ | $z_{\rm Si/T,1} \approx \frac{7}{24}$ |
| Si/T | 4 <i>e</i> | 0 | $\frac{1}{4}$ | $z_{\mathrm{Si/T},2} \approx \frac{1}{24}$ |

Table 17

Wyckoff positions of the proposed orthorhombic superstructure of the tetragonal branch with space group C222₁ (No. 20) and lattice parameters $a \approx \sqrt{2}a_t$, $b \approx c_t$, $c \approx \sqrt{2}a_t$.

| Element | Wyckoff symbol | x | у | z |
|---------|----------------|---|--|------------------------------------|
| R | 4 <i>a</i> | $x_R \approx \frac{1}{4}$ | 0 | 0 |
| R | 4b | 0 | $y_R \approx \frac{1}{4}$ | $\frac{1}{4}$ |
| Т | 4b | $x_T \approx 0$ | $y_T \approx \frac{4}{12}$ | $z_T \approx \frac{1}{4}$ |
| Si | 4b | $x_{{ m Si},1}pprox 0$ | $y_{\mathrm{Si},1} \approx \frac{2}{12}$ | $z_{\rm Si,1} \approx \frac{1}{4}$ |
| Si | 8 <i>c</i> | $x_{\mathrm{Si},2} \approx \frac{1}{4}$ | $y_{\mathrm{Si},2} \approx \frac{1}{12}$ | $z_{\mathrm{Si},2} \approx 0$ |

APPENDIX **B**

Fundamentals of the DFT calculations

To calculate the formation energies with DFT, it is necessary to know the energy of the components that make up the compound. Table 19 contains a list of the underlying singleelement compounds used to calculate the formation energies in Table 18.

Table 18

Formation energies (eV) and lattice parameters (Å) calculated with DFT.

Formation energies are given for R_2Si_4 and R_2TSi_3 compounds, respectively (same amount of atoms within calculated range). Compounds marked with * have already been reported in the literature.

| | Structure type | Reported | | | Calculated | | | |
|--|-------------------------------------|----------|---|--------|------------|------|-------|----------------------|
| Compound | | a | b | С | a | b | С | $\Delta E^{\rm tot}$ |
| Co series | | | | | | | | |
| La2CoSi3 | Ce ₂ CoSi ₃ * | 8.185 | а | 4.350 | 8.14 | а | 4.34 | -4.52 |
| Ce ₂ CoSi ₃ | Ce ₂ CoSi ₃ * | 8.110 | а | 4.220 | 8.01 | а | 4.08 | -4.61 |
| Pr ₂ CoSi ₃ | Ce ₂ CoSi ₃ | _ | - | - | 8.03 | а | 4.11 | -4.58 |
| La2CoSi3 | Ce ₂ CoSi ₃ * | 8.185 | а | 4.350 | 8.14 | а | 4.34 | -4.52 |
| Ce ₂ CoSi ₃ | Ce ₂ CoSi ₃ * | 8.110 | а | 4.220 | 8.01 | а | 4.08 | -4.61 |
| Pr ₂ CoSi ₃ | Ce ₂ CoSi ₃ | - | - | - | 8.03 | а | 4.11 | -4.58 |
| Nd ₂ CoSi ₃ | Ce ₂ CoSi ₃ | _ | - | - | 8.04 | а | 4.15 | -4.37 |
| Rh series | | | | | | | | |
| Eu2RhSi3 | Ce ₂ CoSi ₃ | - | - | - | 8.26 | а | 4.27 | -4.35 |
| | Er2RhSi3 | - | - | - | 8.26 | а | 8.55 | -4.34 |
| Gd ₂ RhSi ₃ | Er2RhSi3* | 8.112 | а | 7.976 | 8.21 | а | 8.02 | -6.68 |
| Tb2RhSi3 | Er2RhSi3* | 8.110 | а | 7.860 | 8.18 | а | 7.90 | -5.51 |
| Dy ₂ RhSi ₃ | Er2RhSi3* | 8.097 | а | 7.823 | 8.18 | а | 7.90 | -5.45 |
| Ho ₂ RhSi ₃ | Er2RhSi3* | 8.086 | а | 7.804 | 8.18 | а | 7.89 | -5.31 |
| Pt series | | | | | | | | |
| Eu2PtSi3 | Ce ₂ CoSi ₃ | - | - | - | 8.27 | а | 4.34 | -5.11 |
| | Er ₂ RhSi ₃ | - | - | - | 8.27 | а | 8.67 | -5.11 |
| Gd ₂ PtSi ₃ | Ce ₂ CoSi ₃ | - | - | - | 8.17 | а | 4.14 | -5.97 |
| | Er2RhSi3* | 8.139 | a | 8.303 | 8.17 | 8.17 | 8.28 | -5.97 |
| Tb ₂ PtSi ₃ | Ce ₂ CoSi ₃ | - | - | - | 8.15 | а | 4.08 | -5.92 |
| | $Er_2RhSi_3 (P\overline{6}2c)^*$ | 8.122 | а | 8.237 | 8.16 | а | 8.18 | -6.17 |
| | P1 | - | - | - | 8.16 | а | 8.17 | -6.18 |
| Dy ₂ PtSi ₃ | Ce ₂ CoSi ₃ | - | - | - | 8.16 | а | 4.07 | -5.84 |
| | $Er_2RhSi_3 (P\overline{6}2c)^*$ | - | - | - | 8.22 | 8.23 | 8.33 | -6.14 |
| | P1 | 8.100 | а | 8.200 | 8.16 | а | 8.14 | -6.14 |
| Ho ₂ PtSi ₃ | Ce ₂ CoSi ₃ | - | - | - | 8.16 | а | 4.07 | -5.77 |
| | Er ₂ RhSi ₃ | - | - | - | 8.16 | а | 8.13 | -6.04 |
| | Er_2RhSi_3 (P62c) | - | - | - | 8.16 | 8.16 | 8.10 | -6.04 |
| | P1 | - | - | - | 8.16 | а | 8.11 | -6.05 |
| La_2PdSi_3 | | | | | | | | |
| La ₂ PdSi ₃ | Ce ₂ CoSi ₃ * | _ | - | - | 8.34 | а | 4.38 | -5.54 |
| SrSi ₂ versus BaSi ₂ | 2 | | | | | | | |
| SrSi ₂ | ThSi ₂ * | 4.438 | а | 13.830 | 4.46 | 4.46 | 13.82 | -2.21 |
| | AlB_2 | - | - | - | 4.14 | а | 4.64 | -1.90 |
| BaSi ₂ | ThSi ₂ | - | - | _ | 4.67 | 4.67 | 14.16 | -2.06 |

Table 15 (continued)

| Compound | Structure type | Reported | | | Calculated | | | |
|--|---|----------|--------|--------|------------|-------|-------|----------------------|
| | | a | b | С | a | b | с | $\Delta E^{\rm tot}$ |
| | AlB ₂ | _ | - | _ | 4.17 | а | 5.06 | -2.06 |
| Sr ₂ AgSi ₃ versus | Ba_2AgSi_3 | | | | | | | |
| Sr ₂ AgSi ₃ | Ba ₄ Li ₂ Si ₆ | - | - | _ | 8.48 | 14.69 | 18.56 | -2.83 |
| 200 | Ca ₂ AgSi ₃ | - | - | _ | 8.48 | 9.28 | 14.67 | -2.74 |
| Ba ₂ AgSi ₃ | Ba4Li2Si6* | 8.613 | 14.927 | 19.639 | 8.63 | 14.97 | 19.84 | -2.74 |
| | Ca ₂ AgSi ₃ | - | _ | - | 9.11 | 10.19 | 15.58 | -2.36 |
| Potential tetrago | nal structure with ordered Si/ | T sites | | | | | | |
| NdSi ₂ | ThSi ₂ * | 3.968 | а | 13.715 | 4.12 | а | 14.05 | -3.97 |
| | AlB ₂ | - | _ | _ | 4.08 | а | 4.13 | -4.20 |
| Nd ₂ AgSi ₃ | ThSi ₂ * | 4.175 | а | 14.310 | - | - | - | _ |
| | POTS | - | - | _ | 5.96 | 5.93 | 14.54 | -3.72 |
| | Ce ₂ CoSi ₃ | - | - | _ | 8.35 | а | 4.28 | -3.69 |
| Nd ₂ PdSi ₃ | AlB ₂ * | 4.103 | а | 4.204 | - | - | - | - |
| | Ce ₂ CoSi ₃ | _ | - | _ | 8.26 | а | 4.24 | -5.17 |
| Nd ₂ CuSi ₃ | Ce ₂ CoSi ₃ | _ | - | _ | 8.06 | а | 4.26 | -4.23 |
| | $Er_2RhSi_3 (P\overline{6}2c)^*$ | 8.076 | а | 8.440 | 8.07 | а | 8.46 | -4.54 |
| | P1 | _ | - | _ | 8.06 | а | 8.44 | -4.14 |
| Nd ₂ NiSi ₃ | Ce2CoSi3* | 4.020 | а | 4.190 | 7.98 | а | 4.14 | -6.32 |

Table 19

Space groups of the unary R crystals used for standardization of the formation energies.

| Atomic number | Element | Space group | ICSD code |
|---------------|---------|--------------------------------|-----------|
| 14 | Si | $Ed\overline{3}m$ (No. 227) | 51688 |
| 27 | Co | $P6_{2}/mmc$ (No. 194) | 184251 |
| 28 | Ni | $Fm\overline{3}m$ (No. 225) | 646089 |
| 38 | Sr | $Fm\overline{3}m$ (No. 225) | 652875 |
| 45 | Rh | $Fm\overline{3}m$ (No. 225) | 171677 |
| 46 | Pd | Fm3m (No. 225) | 76148 |
| 47 | Ag | Fm3m (No. 225) | 181730 |
| 56 | Ba | Im3m (No. 229) | 108091 |
| 57 | La | P6 ₃ /mmc (No. 194) | 641382 |
| 58 | Ce | Fm3m (No. 225) | 620620 |
| 59 | Pr | <i>Fm</i> 3 <i>m</i> (No. 225) | 649185 |
| 60 | Nd | P6 ₃ /mmc (No. 194) | 164281 |
| 63 | Eu | Im3m (No. 229) | 604033 |
| 64 | Gd | P6 ₃ /mmc (No. 194) | 184250 |
| 65 | Tb | $R\overline{3}mH$ (No. 166) | 652944 |
| 66 | Dy | P6 ₃ /mmc (No. 194) | 95172 |
| 67 | Ho | $R\overline{3}mH$ (No. 166) | 639322 |
| 78 | Pt | <i>Fm</i> 3 <i>m</i> (No. 225) | 649490 |

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